



Advancement in the understanding of the field and frequency dependent microwave surface resistance of niobium

Martina Martinello

18th International Conference on RF Superconductivity

18 July 2017

Outline

- Experimental method and parameters extrapolation
- R_{BCS} field dependence
- Trapped flux sensitivity
- N-infusion at 1.3 GHz
- Conclusions

Outline

- Experimental method and parameters extrapolation
- R_{BCS} field dependence
- Trapped flux sensitivity
- N-infusion at 1.3 GHz
- Conclusions

Analyzed Cavities

N-doping
 N-infusion
 120C baking
 EP/BCP

1.3 GHz, 2 K



	650 MHz	1.3 GHz	2.6 GHz	3.9 GHz
EP		✓		
BCP		✓		✓
120C baking	✓	✓	✓	✓
120C infusion		✓		
160C infusion		✓		
2/6 N-doping	✓	✓	✓	✓

Data Analysis

For each cavity:

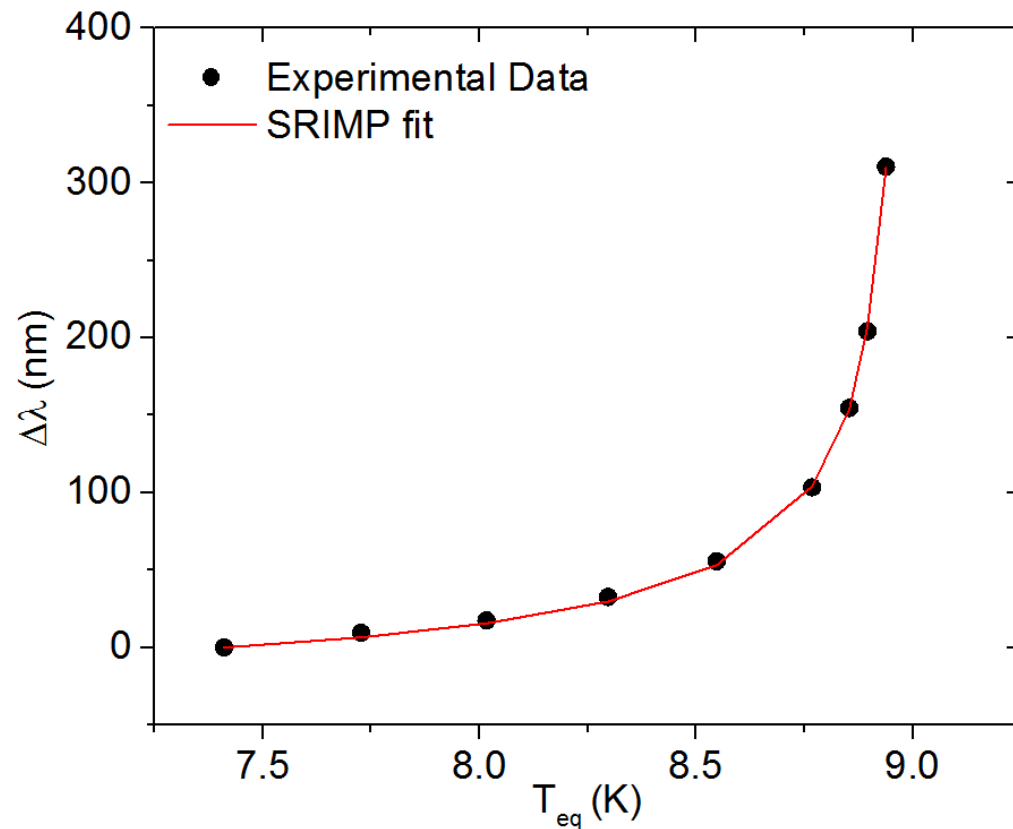
- Mean free path extrapolation: the mfp ℓ specifies the impurity content after each treatment
- Surface resistance decomposition:

$$R_S (2 K) = R_{BCS} (2 K) + R_{Fl} + R_0$$

1. $R_{BCS} (2 K)$: BCS surface resistance at $2 K$
2. R_{Fl} : Trapped flux surface resistance
3. R_0 : Intrinsic residual resistance

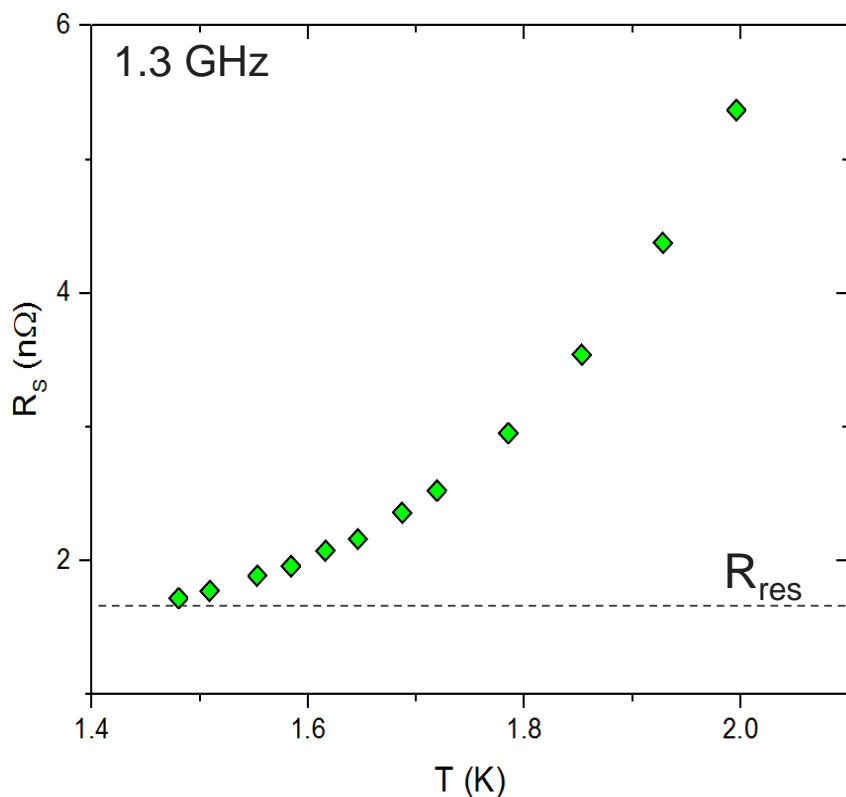
Mean Free Path Calculation

- Measurements of Frequency vs T warming up through T_c : $\Delta f \propto -1/\Delta\lambda$
- $\Delta\lambda$ is interpolated using Halbritter SRIMP code
- The parameters are:
 - Critical temperature:
 $T_c \sim 9.2 K$
 - London penetration depth:
 $\lambda_L = 39 nm$
 - Intrinsic coherent length:
 $\xi_0 = 38 nm$
 - Starting temperature: T_0
 - Mean free path (mfp): ℓ
 - Energy gap: $\Delta/k_B T_c$



1a. BCS Surface Resistance (650 MHz and 1.3 GHz)

$$R_S (2 K) = R_{BCS} (2 K) + R_0 + R_{Fl}$$



$$R_S (2 K) = R_{BCS} (2 K) + R_{res}$$

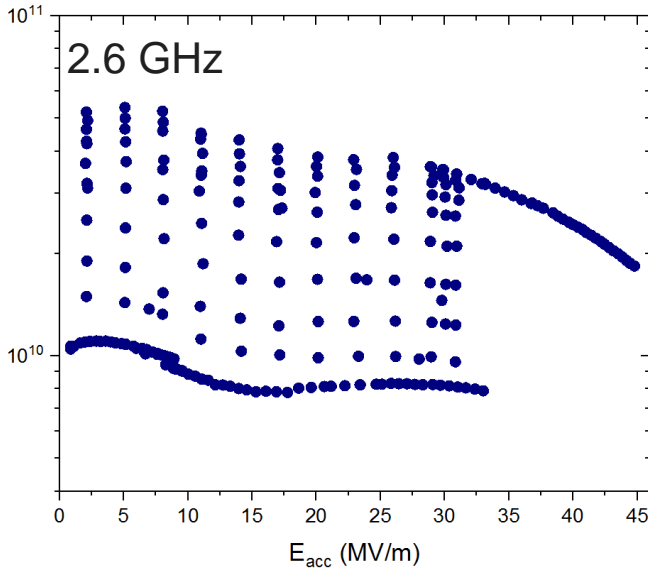
Because of the exponential decreasing with T, R_{BCS} at 1.5 K is negligible at low frequencies :

$$R_S (1.5 K) \sim R_{res}$$

R_{BCS} (2 K) can be calculated as:

$$R_{BCS}(2K) = R_S(2 K) - R_S(1.5 K)$$

1b. BCS Surface Resistance (2.6 and 3.9 GHz)



$$R_S (2 K) = R_{BCS} (2 K) + R_0 + R_{Fl}$$

Fit with SRIMP of R_s (T) acquired at different E_{acc} values:

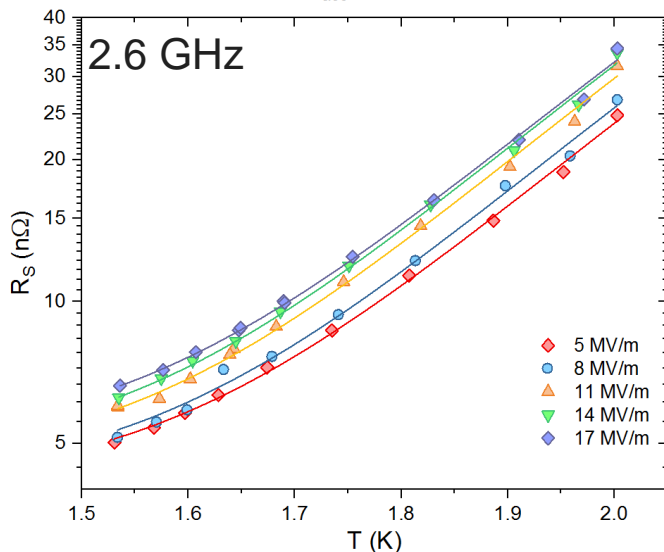
$$R_S = A e^{-\frac{\Delta}{k_B T}} + R_{res}$$



Accurate determination of $R_{res}(E_{acc})$

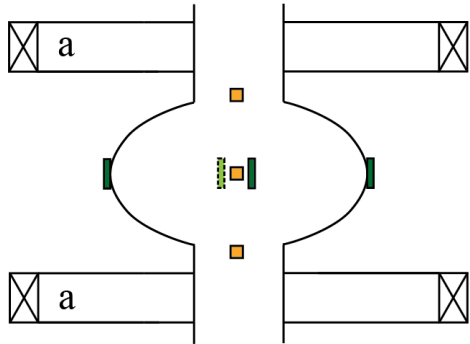
At this point $R_{BCS}(2K)$ can be easily calculated:

$$R_{BCS}(2K) = R_S(2 K) - R_{res}$$



2. Trapped Flux Surface Resistance

$$R_S (2 K) = R_{BCS} (2 K) + R_0 + R_{Fl}$$

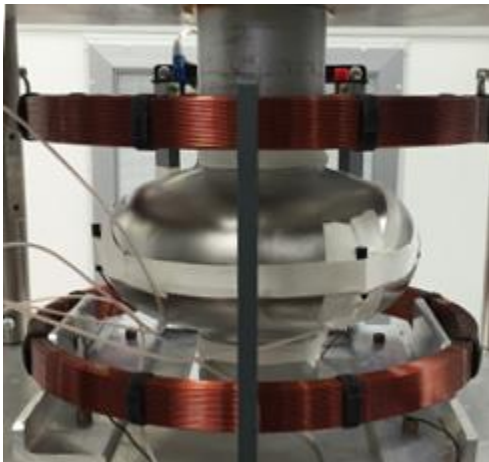


R_{Fl} defines the dissipation due to flux trapped during the SC transition:

$$R_{Fl} = B_{trap} \cdot S$$

$$R_{Fl} = R_S(1.5 K, B_{Trap}) - R_S(1.5 K, B_{Trap} = 0)$$

- $R_S(1.5 K, B_{Trap})$ measured after **slow cooldown** in a known amount of external magnetic field: $B_{ext} = B_{Trap}$
- $R_S(1.5 K, B_{Trap} = 0)$ measured after **fast cooldown** in **compensated magnetic field**: $B_{ext} = 0, R_{fl} = 0$



3. Intrinsic Residual Resistance

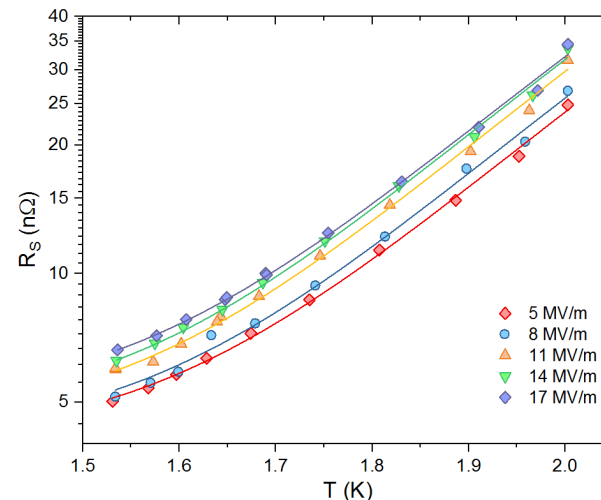
$$R_S (2 K) = R_{BCS} (2 K) + \boxed{R_0} + R_{Fl}$$

- For low frequency cavities the intrinsic residual resistance can be obtained with the low T measurement in absence of B_{trap} :

$$R_0 = R_S(1.5 K, B_{\text{Trap}} = 0)$$

- For high frequency cavities the intrinsic residual resistance has to be calculated by fitting with SRIMP $R_s(T)$ acquired at different E_{acc} values in absence of B_{trap} :

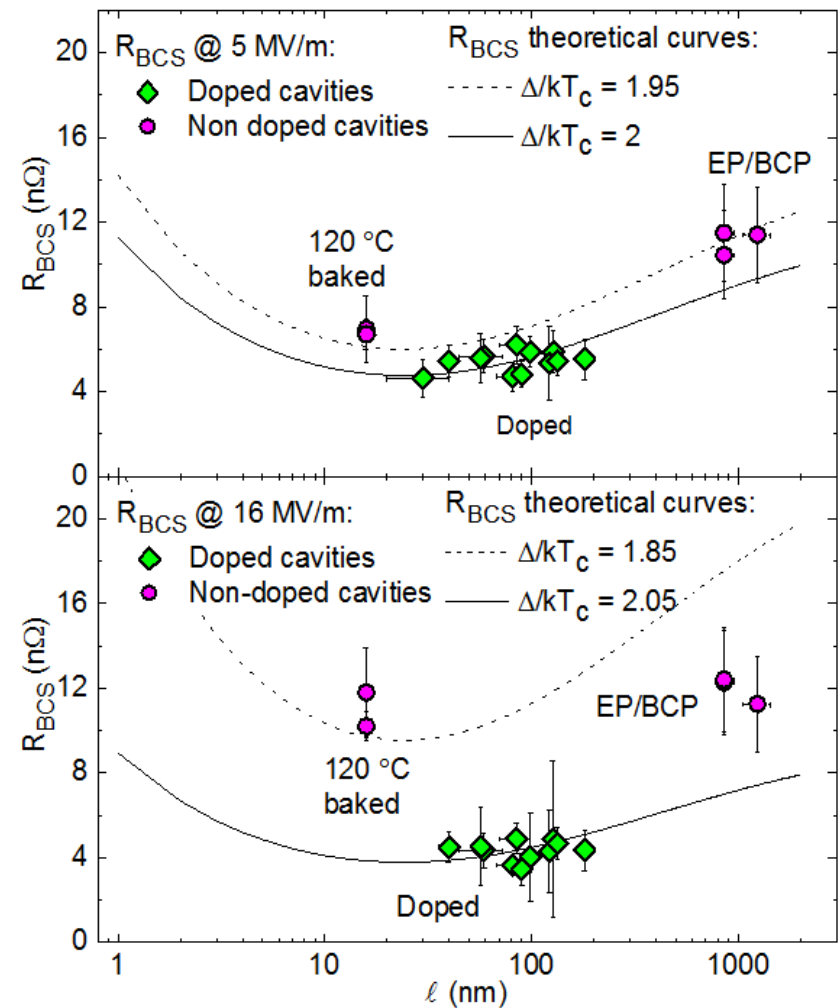
$$R_S = A e^{-\frac{\Delta}{k_B T}} + R_0$$



Outline

- Experimental method and parameters extrapolation
- **R_{BCS} field dependence**
- Trapped flux sensitivity
- N-infusion at 1.3 GHz
- Conclusions

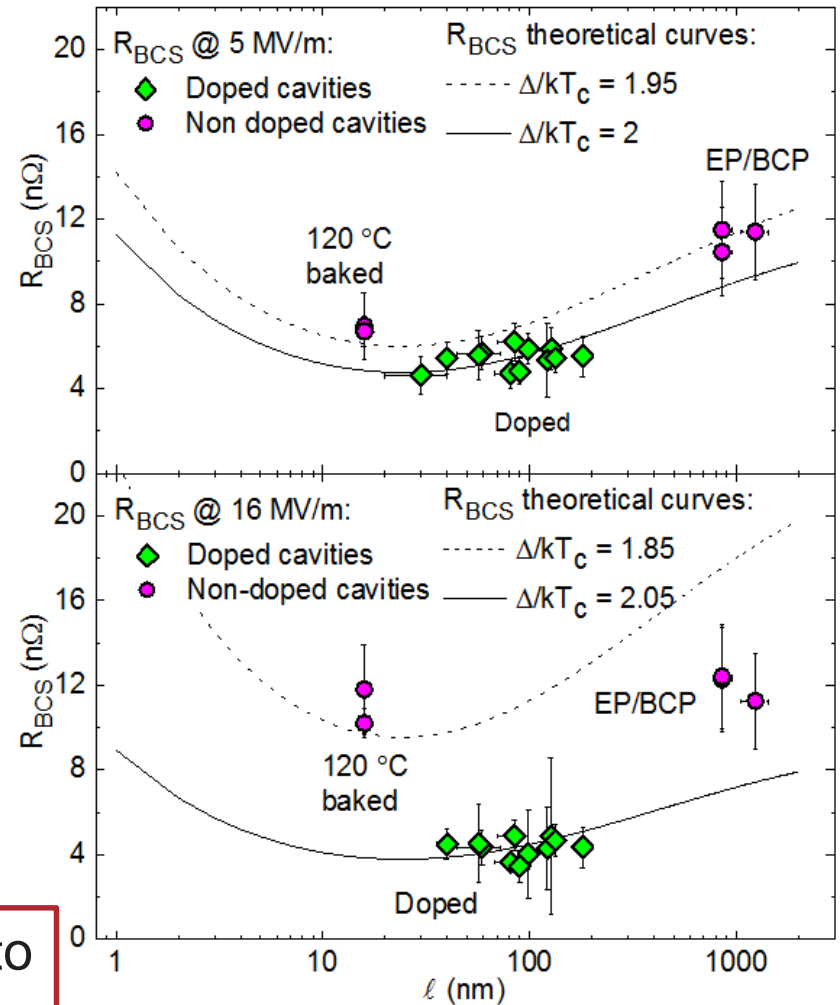
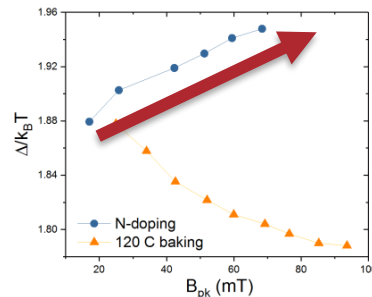
BCS surface resistance (1.3 GHz)



A. Romanenko and A. Grassellino, *App. Phys. Lett.* **102**, 252603 (2013)

M. Martinello et al., *App. Phys. Lett.* **109**, 062601 (2016)

BCS surface resistance (1.3 GHz)



The reduced energy gap Δ/kT_c seems to increase with E_{acc} for N-doped cavities causing the decreasing of R_{BCS}

Field Dependence at Different Frequencies

Different thermal treatments were studied at different frequencies:

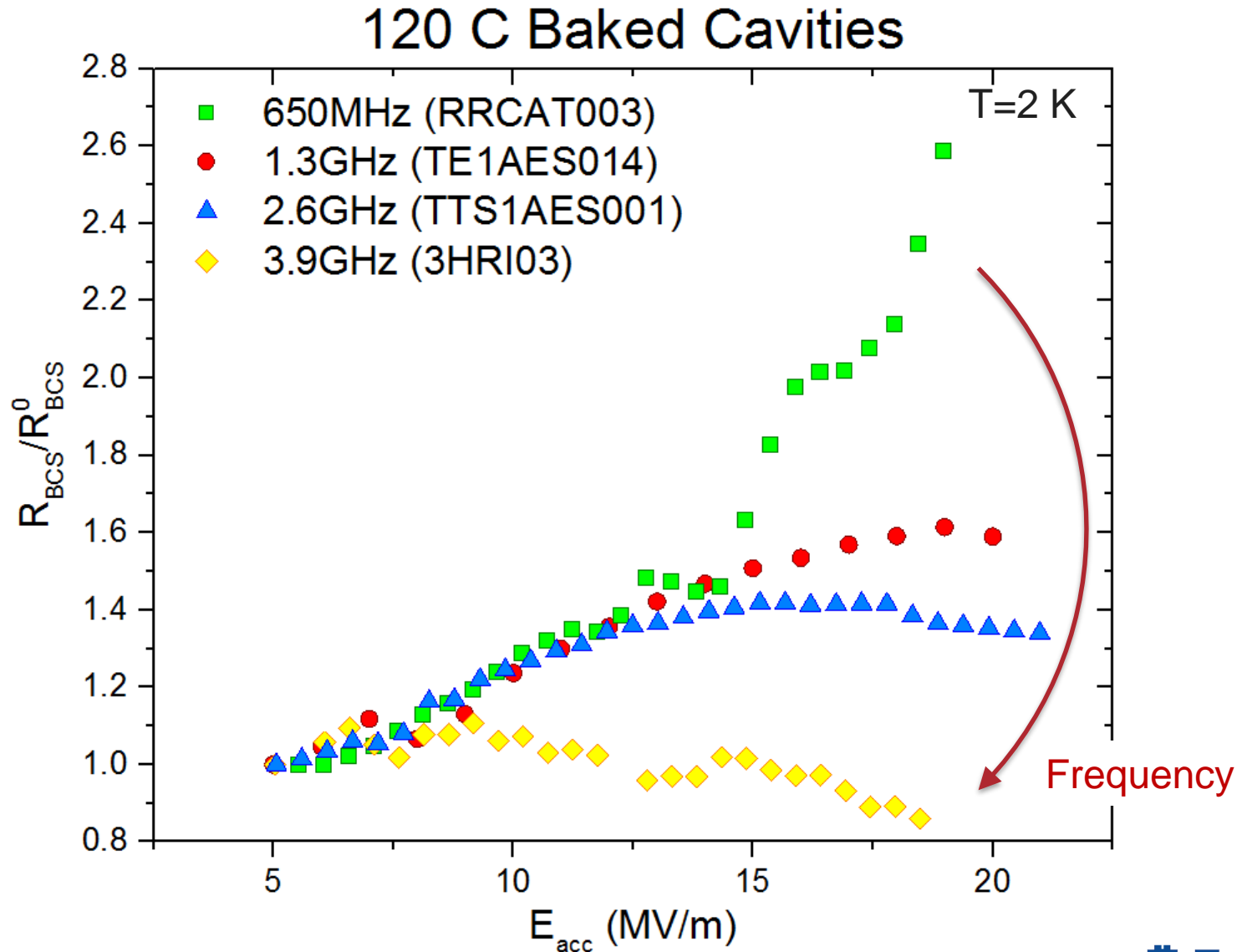
1. 120 C baking
2. Buffer Chemical Polishing (BCP)
3. Nitrogen doping (2/6 recipe)



1.

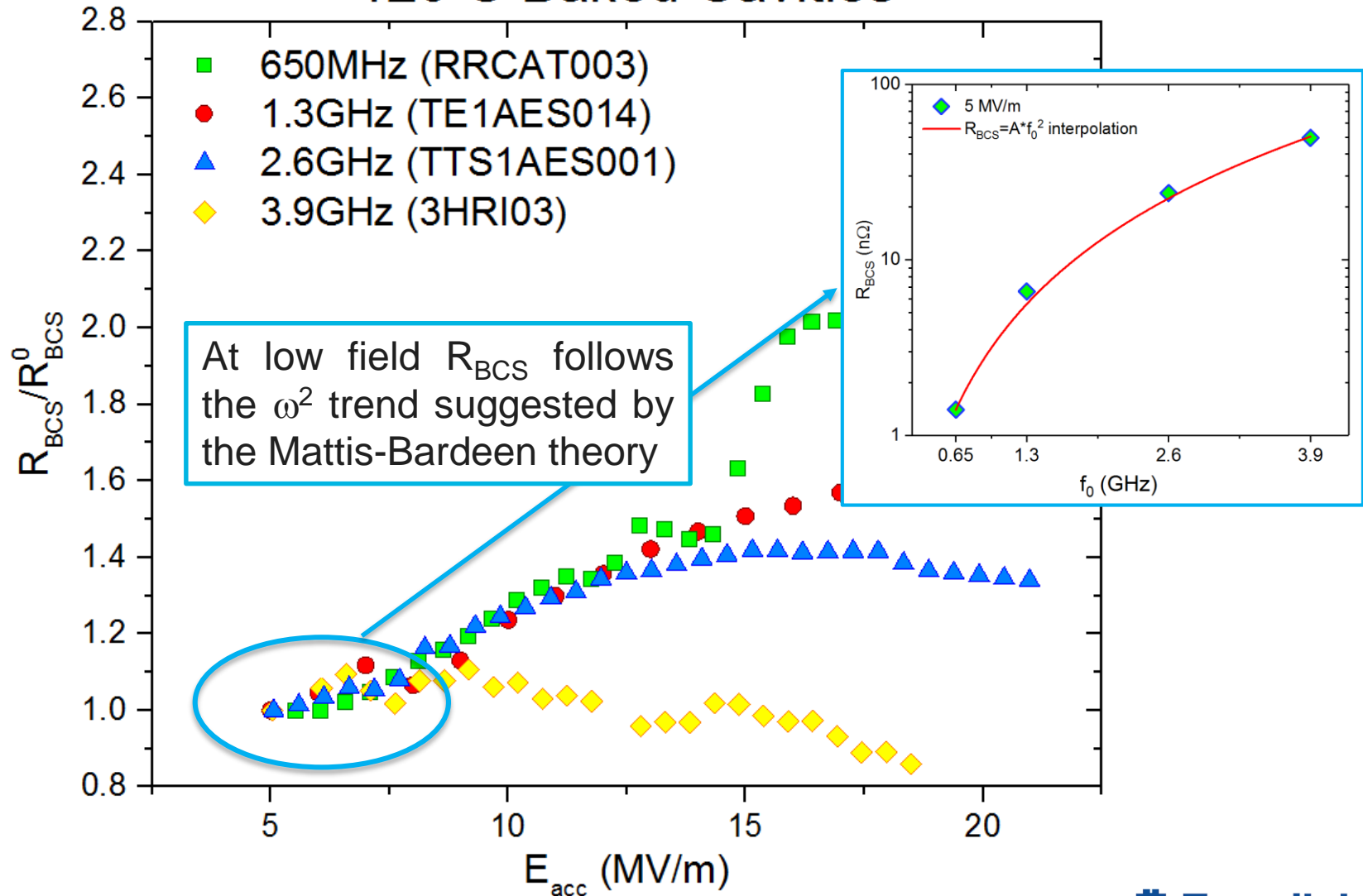
120 C baking

1. Normalized $R_{BCS}(2 K)$ for 120 C Baking

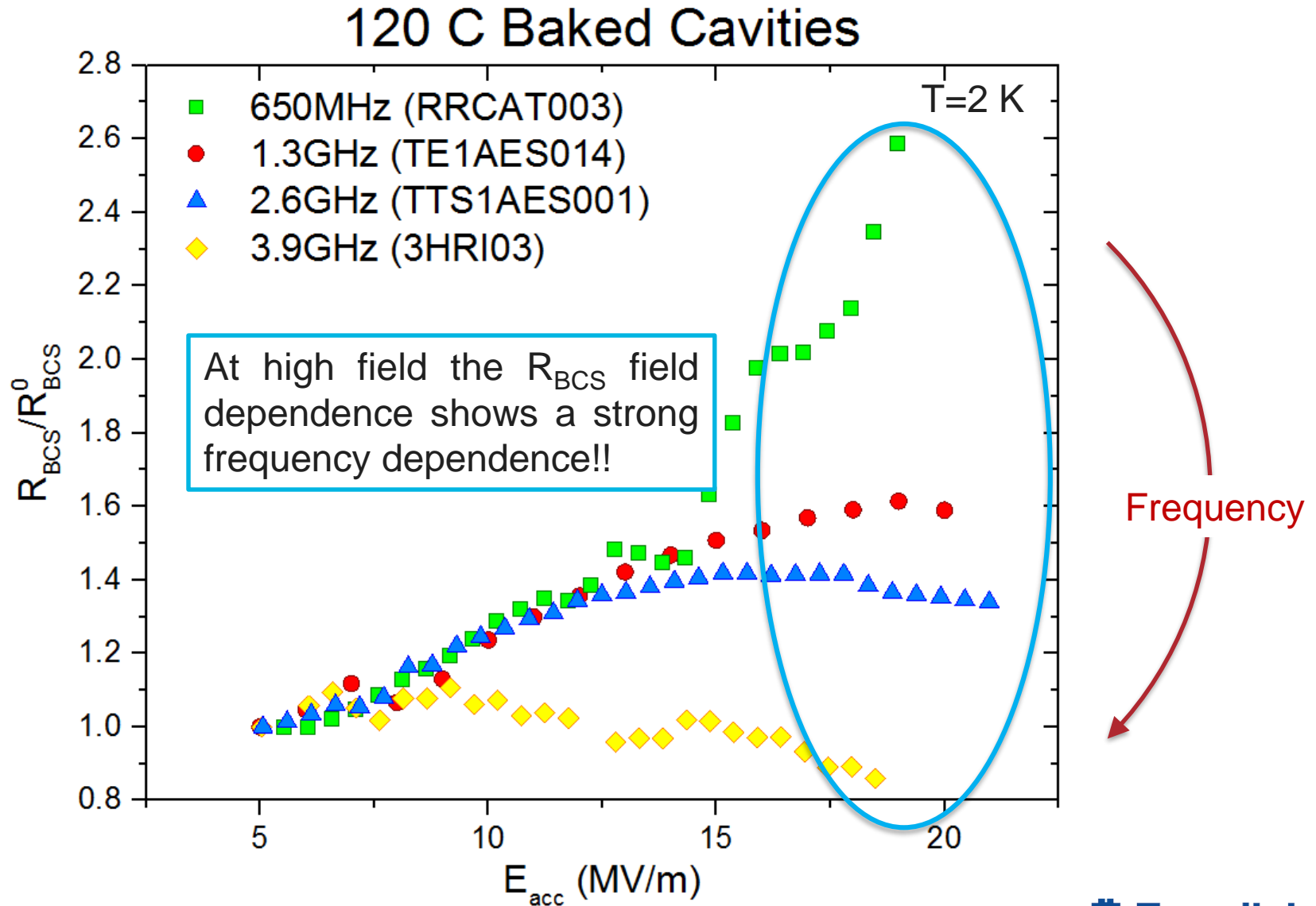


1. Normalized $R_{BCS}(2 K)$ for 120 C Baking

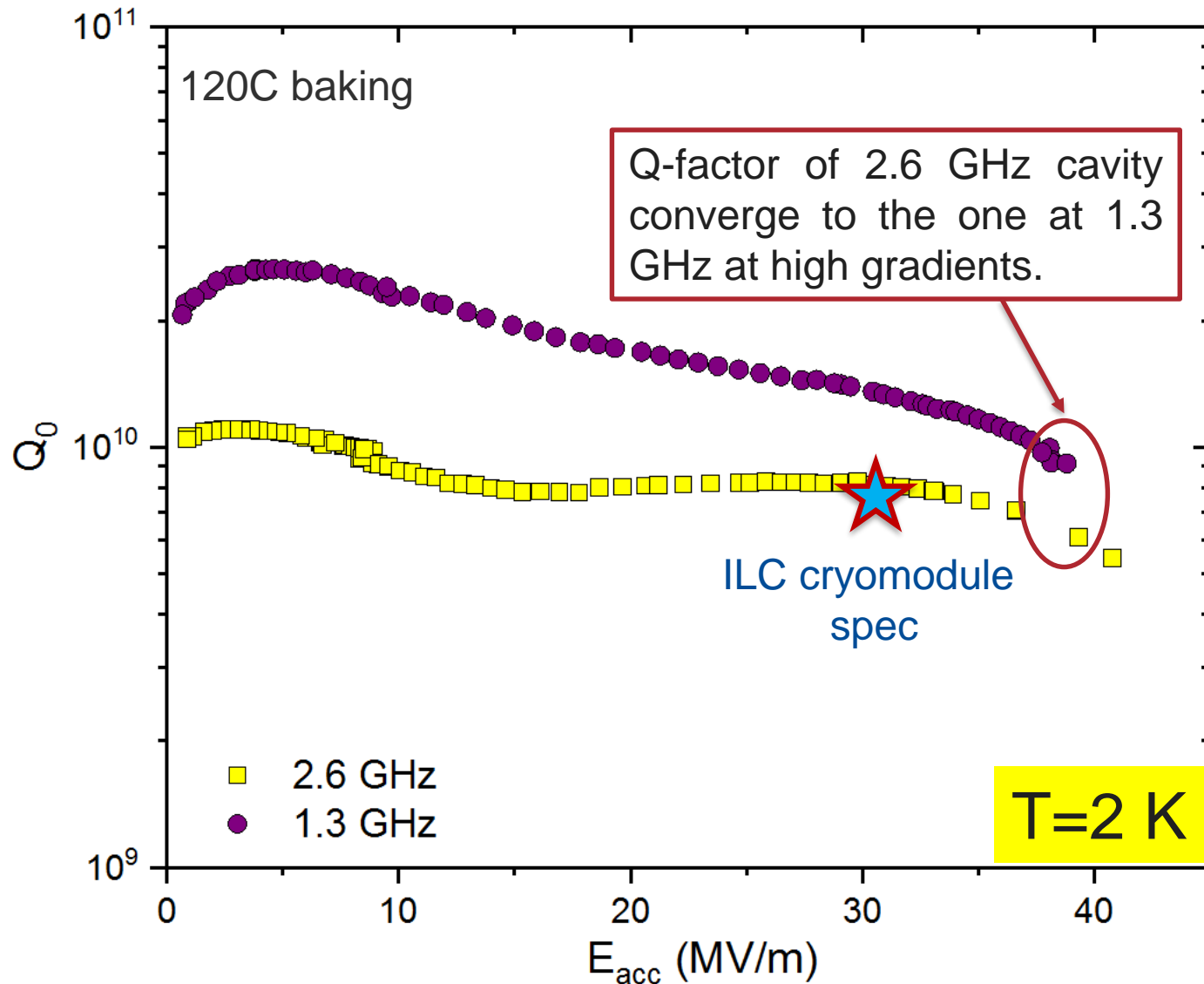
120 C Baked Cavities



1. Normalized $R_{BCS}(2 K)$ for 120 C Baking



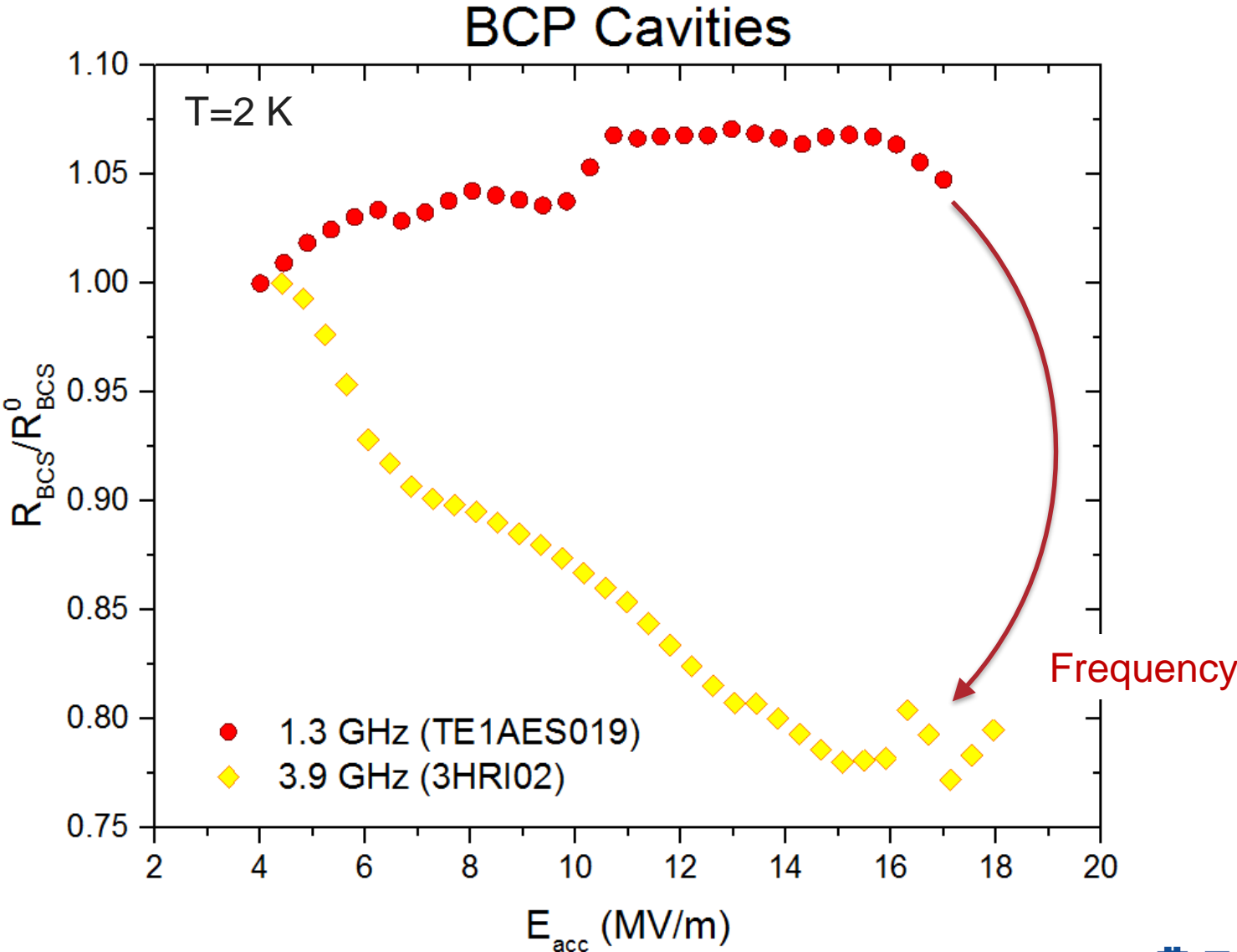
ILC Cryomodule Specifications at 2.6 GHz



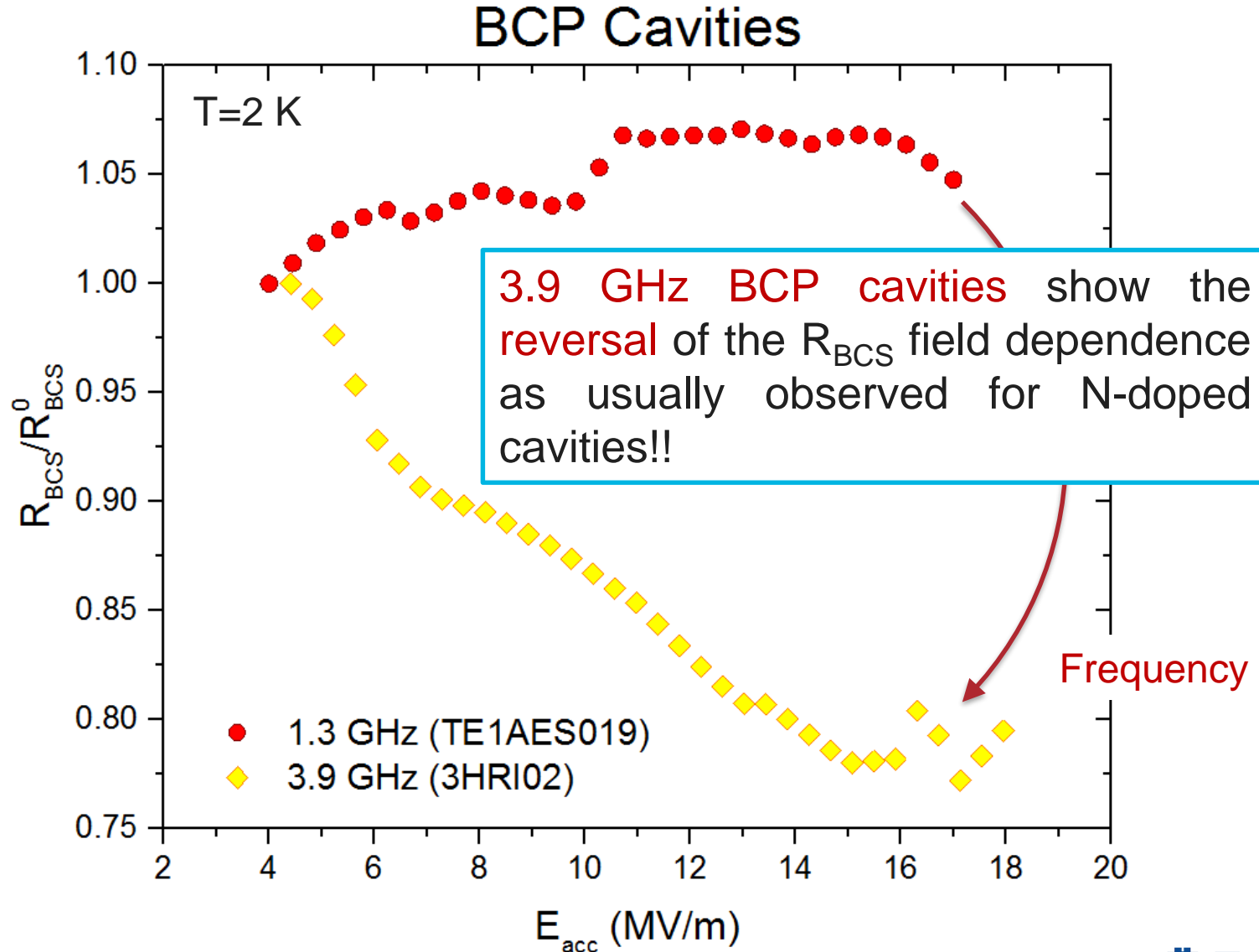
2.

Buffer Chemical Polishing

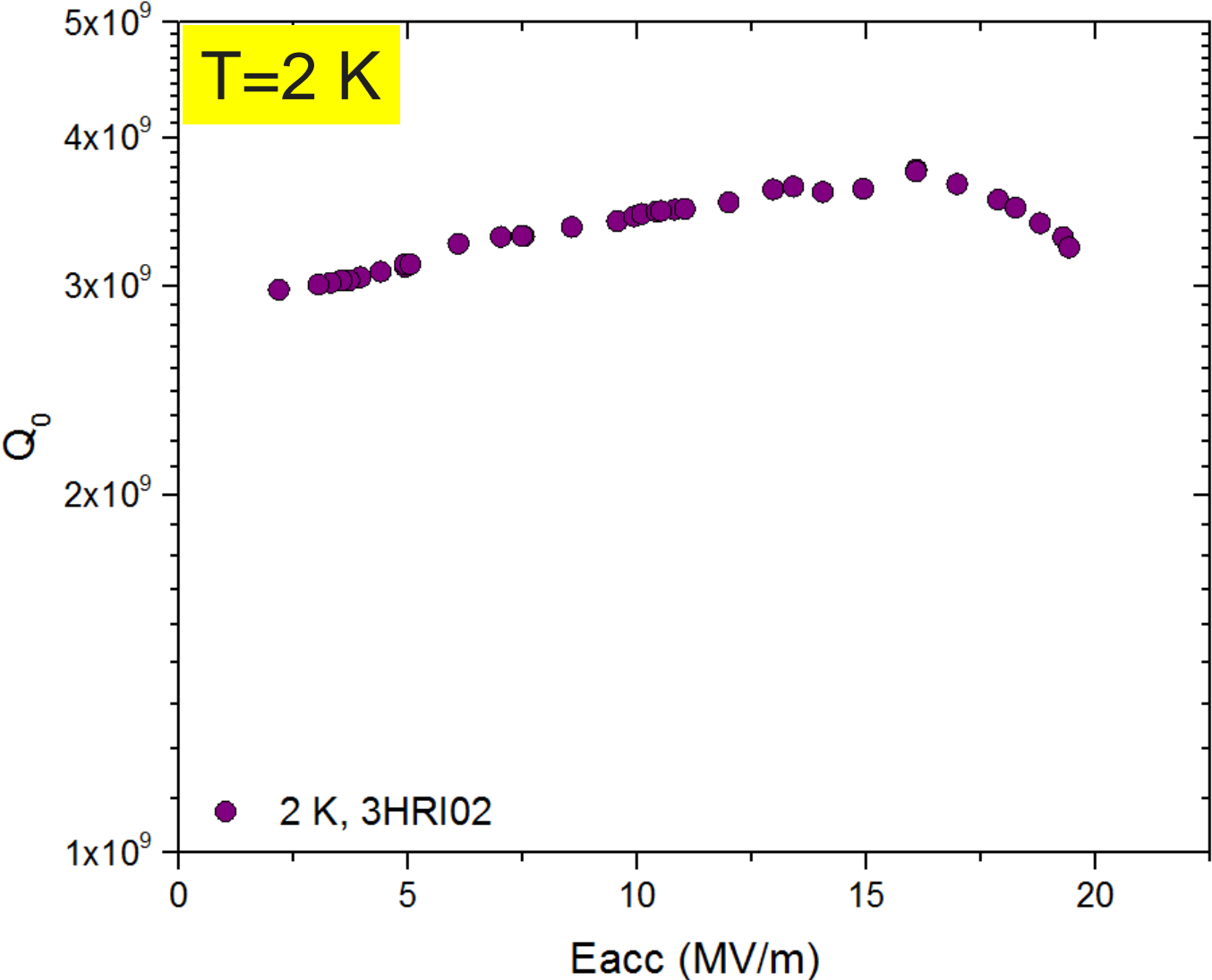
2. Normalized $R_{BCS}(2 K)$ for BCP



2. Normalized $R_{BCS}(2 K)$ for BCP



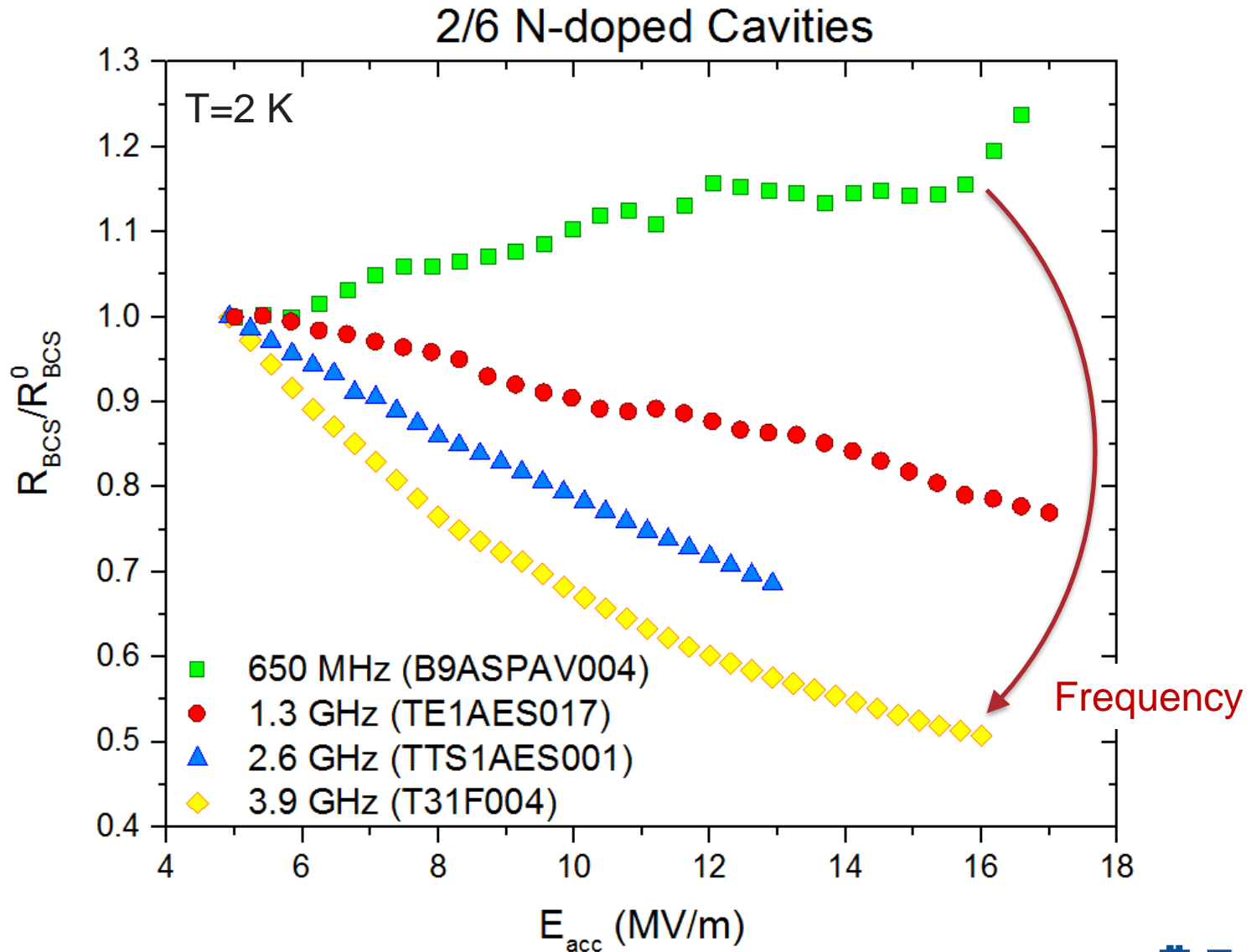
Anti Q-slope in BCP'd 3.9 GHz Cavities



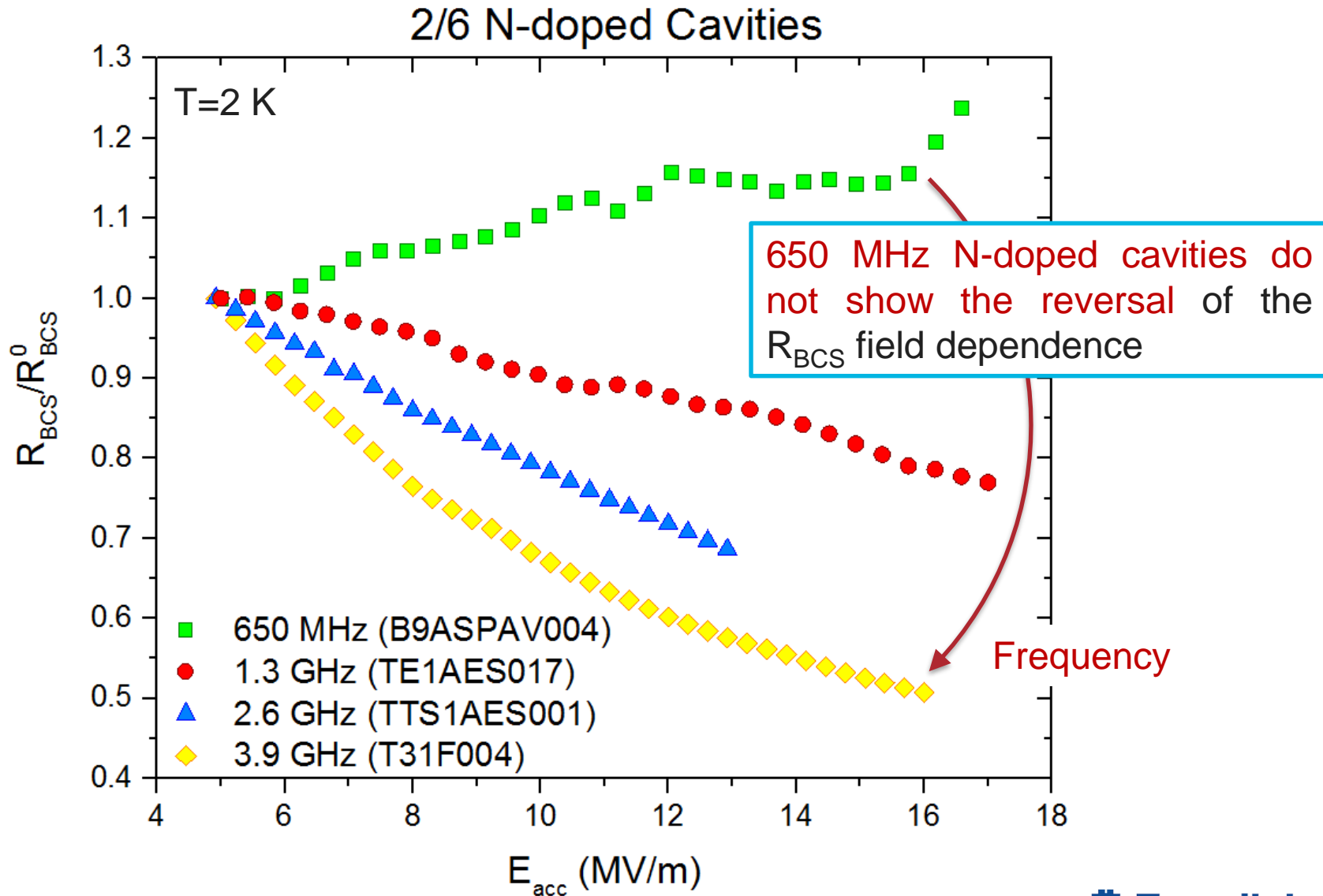
3.

Nitrogen doping

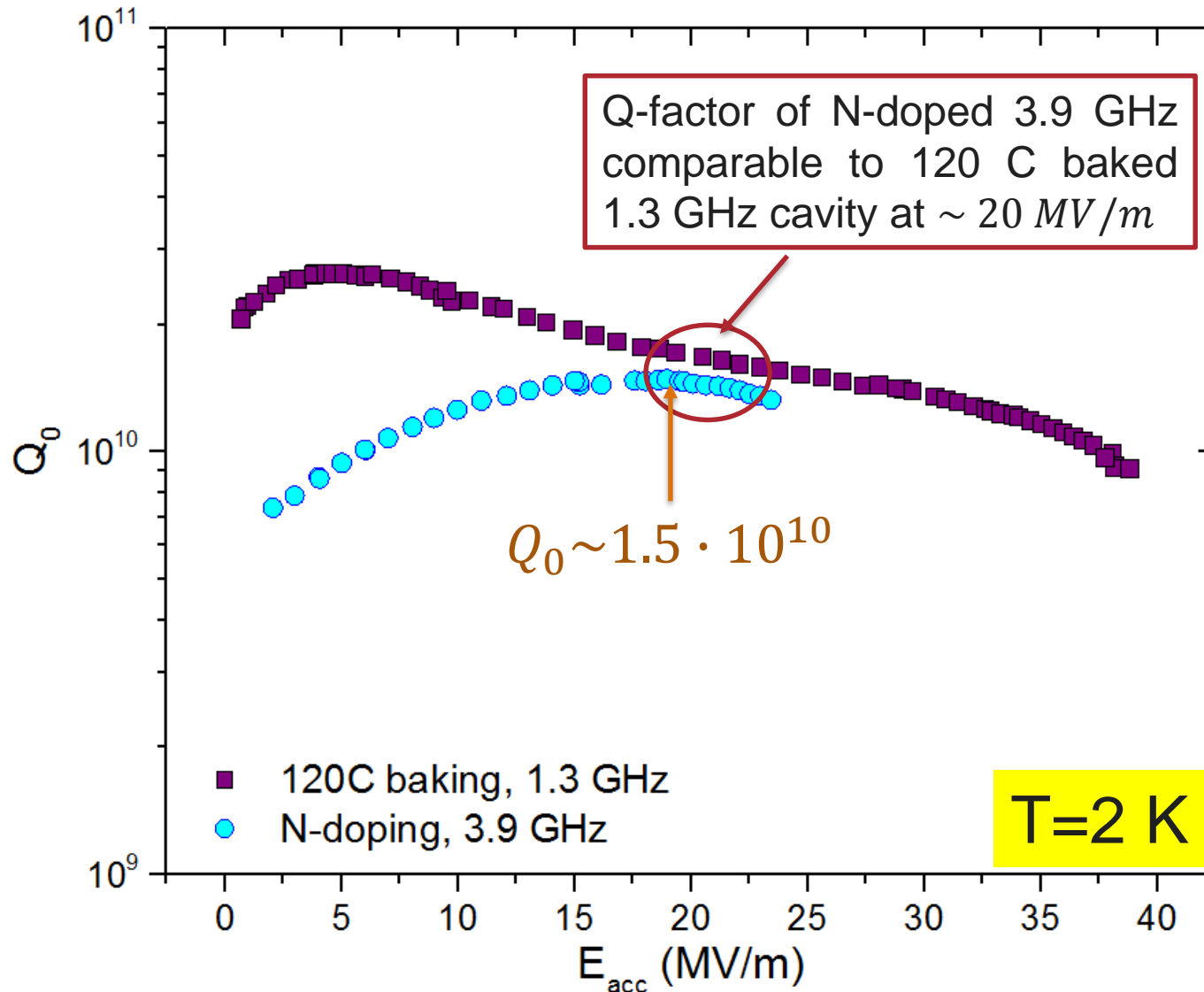
3. Normalized $R_{BCS}(2 K)$ for N-doping



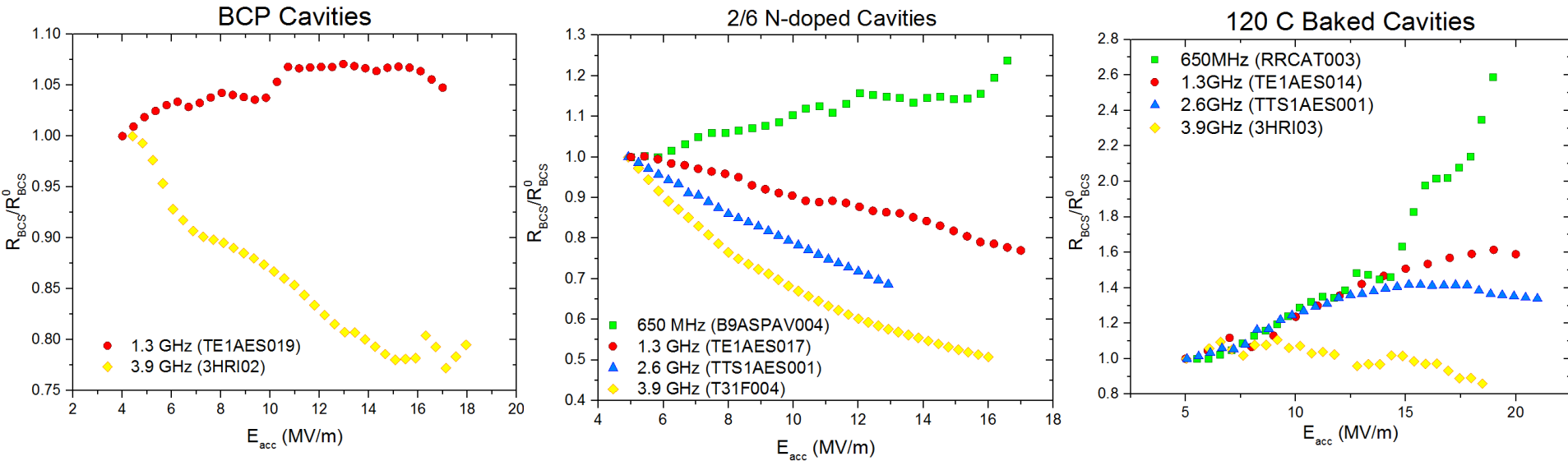
3. Normalized $R_{BCS}(2 K)$ for N-doping



Unprecedented Medium Field Q_0 at 3.9 GHz

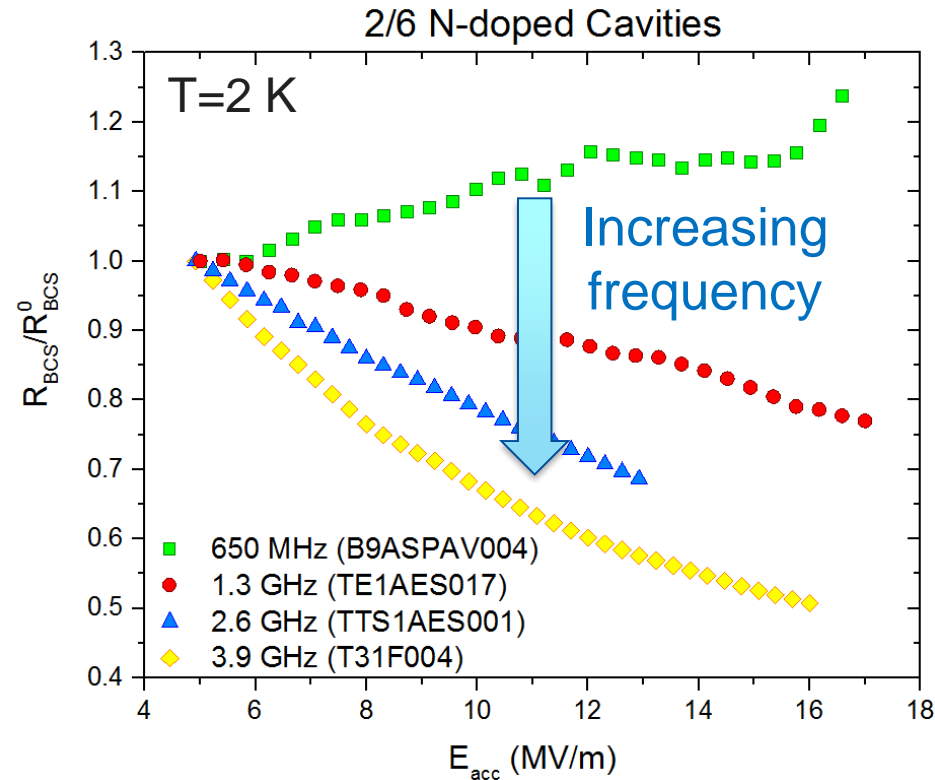
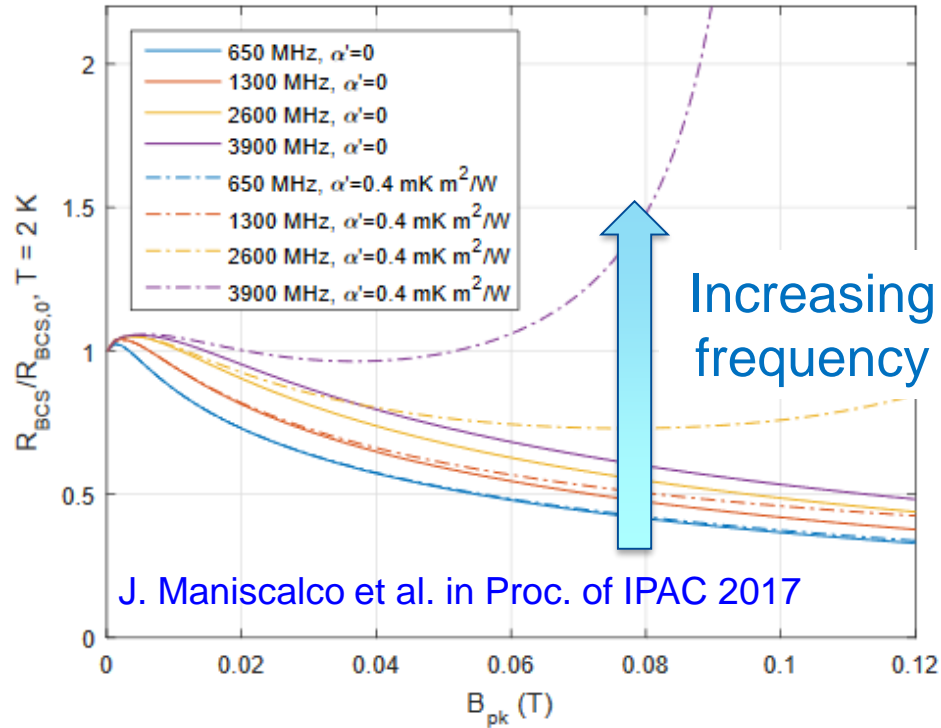


Effect of the frequency on the $R_{BCS}(E_{acc})$ slope



- The physical mechanism underneath the R_{BCS} reversal has a stronger effect at high frequencies
- The R_{BCS} reversal, that has been considered the signature of the N-doped treatment, is actually visible also in clean Nb but at high frequency
- On the other hand, N-doped cavities at low frequencies do not show the R_{BCS} reversal observed at 1.3 GHz

Frequency Dependence NOT Related to QP Overheating

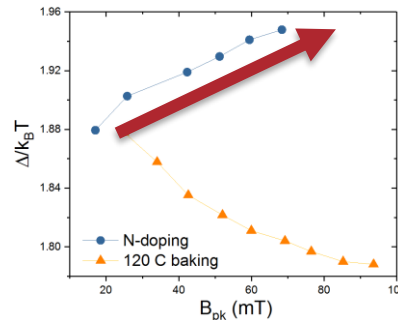


These new experimental findings **disprove** the prediction of the frequency dependence of $R_{BCS}(E_{acc})$ based on the **quasiparticles overheating mechanism**

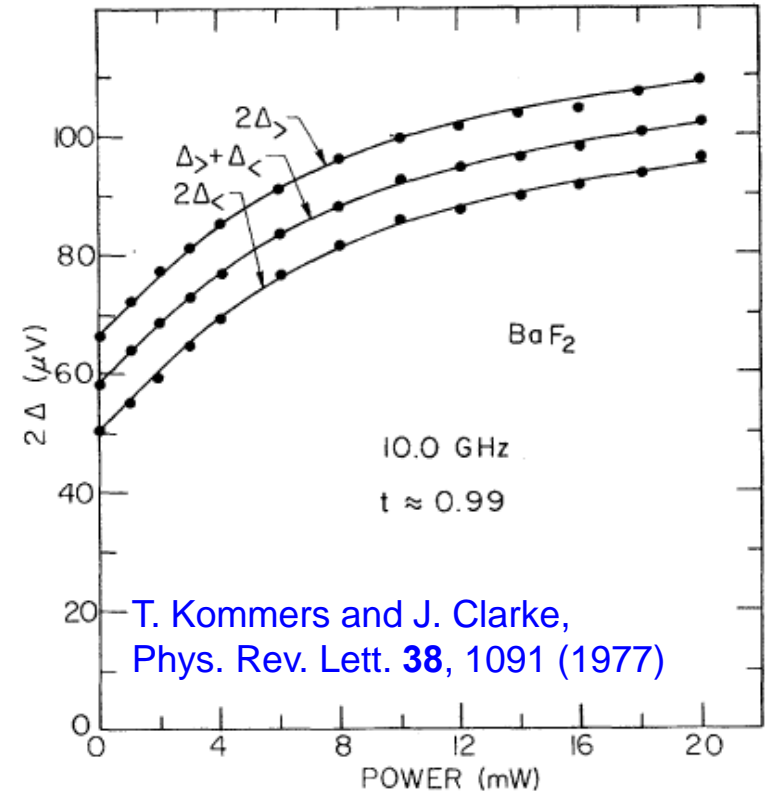
Understanding the reversal of R_{BCS} with the RF field

The non-equilibrium quasiparticle distribution driven by microwave fields is shown to stimulate the superconductivity^{1,2,3}:

- Δ increases with the RF field amplitude (absorbed power)
- R_{BCS} decreases with the RF field amplitude (absorbed power)



Δ increases
driven by E_{acc} ?



¹ G.M. Eliashberg, ZhETF Pis. Red. **11**, 186 (1970)

² J.-J. Chang and D. J. Scalapino, Phys. Rev. B **15**, 2051 (1977)

³ D. J. Goldie and S. Withington, Supercond. Sci. Technol. **26**, 015004 (2013)

Considerations for a Complete R_{BCS} Description

Ideas for a new model to explain the R_{BCS} field-dependent behavior of SRF cavities:

- Take into account the **smearing of the DOS** due to the RF field amplitude (as done in: [A. Gurevich, Phys. Rev. Lett. 113, 087001 \(2014\)](#))
- Take into account **non-equilibrium effects**:
 - Enhanced in presence of high frequencies
 - Enhanced by large accelerating field (higher number of QP involved)
 - Potentially enhanced by the presence of impurities that may modify the relaxation and recombination times of quasi-particles
 - Different impurities may have different effects because of their different cross section

Considerations for a Complete R_{BCS} Description

Ideas for a new model to explain the R_{BCS} field-dependent behavior of SRF cavities:

- Take into account the amplitude of the field
- Take into account the frequency of the field

Model under development in collaboration with Northwestern University

Northwestern, Fermi National Accelerator Lab
Launch New Research Center

Partnership expected to advance wide range of science, including medicine, energy

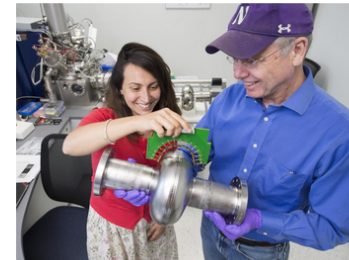
By Roger Anderson, June 20, 2017

Northwestern University and the Department of Energy's Fermi National Accelerator Laboratory (Fermilab) have established a new collaboration that will enhance the world-class discovery that is a hallmark of each institution.

The Center for Applied Physics and Superconducting Technologies (CAPST) formally recognizes a broad intersection of scientific pursuits and complementary state-of-the-art facilities. CAPST lays the groundwork for the cross-utilization of technical expertise, facilities, and equipment, and establishes a partnership that will foster joint scientific research, mentorship, and new opportunities for researchers, graduate students, and postdoctoral fellows.

Research at the center will include a focus on advancing superconductivity, which is expected to produce societal gains in the fields of particle physics, solid-state physics, materials science, medicine, energy and environmental sciences.

Superconductors are materials that conduct electricity with no resistance and superconducting magnets — like those used in Magnetic Resonance Imaging (MRI) and particle accelerators — must



Anna Grassellino and James Sauls, Center for Applied Physics and Superconducting Technologies codirectors, hold a superconducting RF cavity inside the Material Science Lab at the Department of Energy's Fermi National Accelerator Laboratory. Photo by Reidar Hahn

Different impurities may have different effects because of their different cross section

Outline

- Experimental method and parameters extrapolation
- R_{BCS} field dependence
- **Trapped flux sensitivity**
- N-infusion at 1.3 GHz
- Conclusions

Sensitivity vs Mean Free Path

$$S = \frac{R_{Fl}}{B_{trap}}$$

- Bell-shaped trend of S as a function of mean free path
- For N-doped cavities, sensitivity minimization for either very light or very heavy doping treatments

M. Martinello et al., App. Phys. Lett. **109**, 062601 (2016)

M. Martinello et al., in Proc. of SRF 2015

➤ **Dissipation due to vortex oscillation under the RF field**

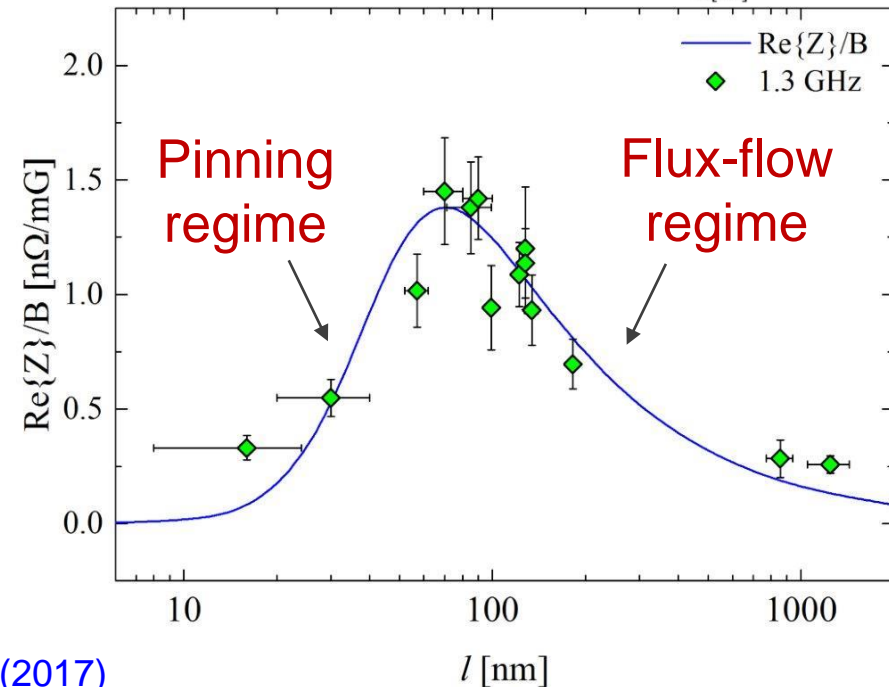
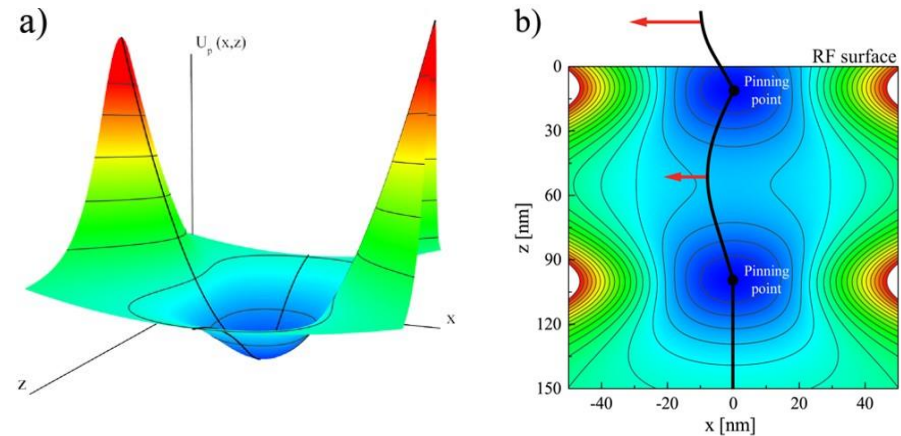
We can define two regimes:

1. Large l ($p \rightarrow 0$) – flux flow regime:

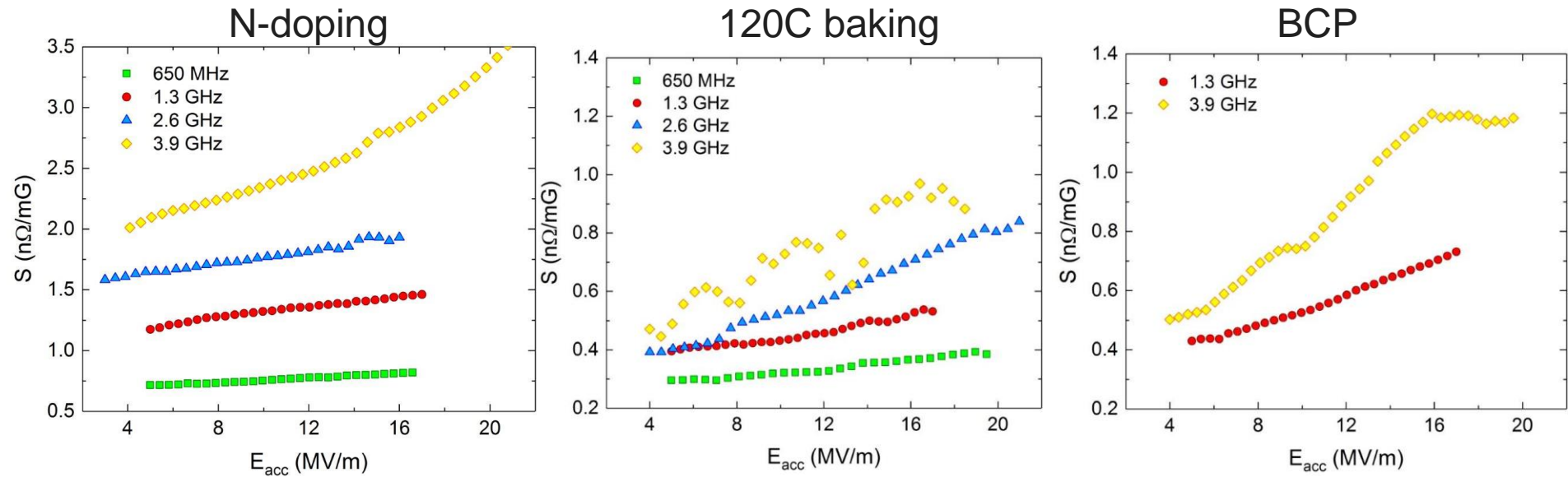
$$\Rightarrow \rho_1(l) \sim \frac{1}{\eta}, \text{ decreases with } l$$

2. Small l ($\eta \rightarrow 0$) – pinning regime:

$$\Rightarrow \rho_1(l) \sim \frac{\eta \omega^2}{p^2}, \text{ increases with } l$$

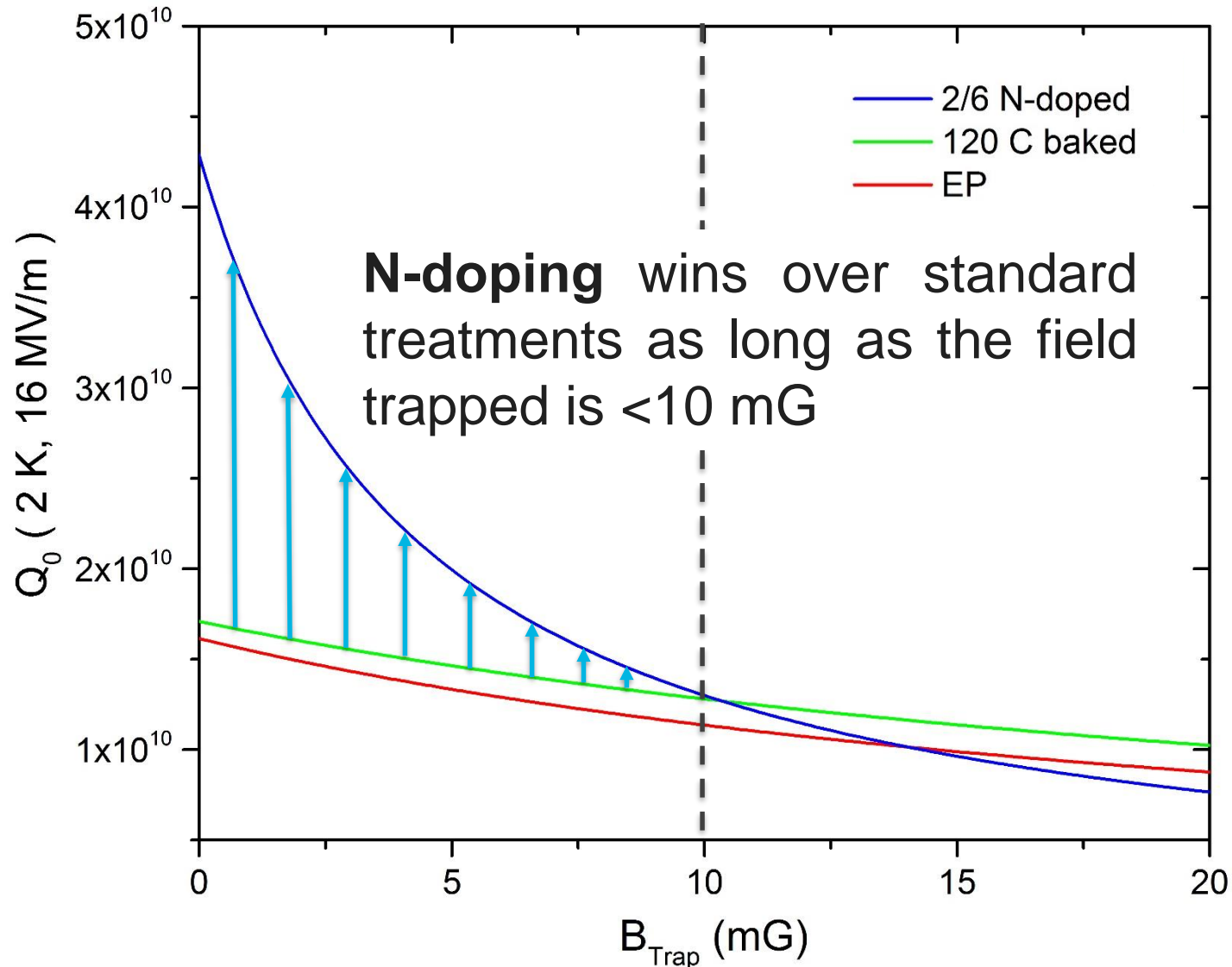


Sensitivity for different frequencies

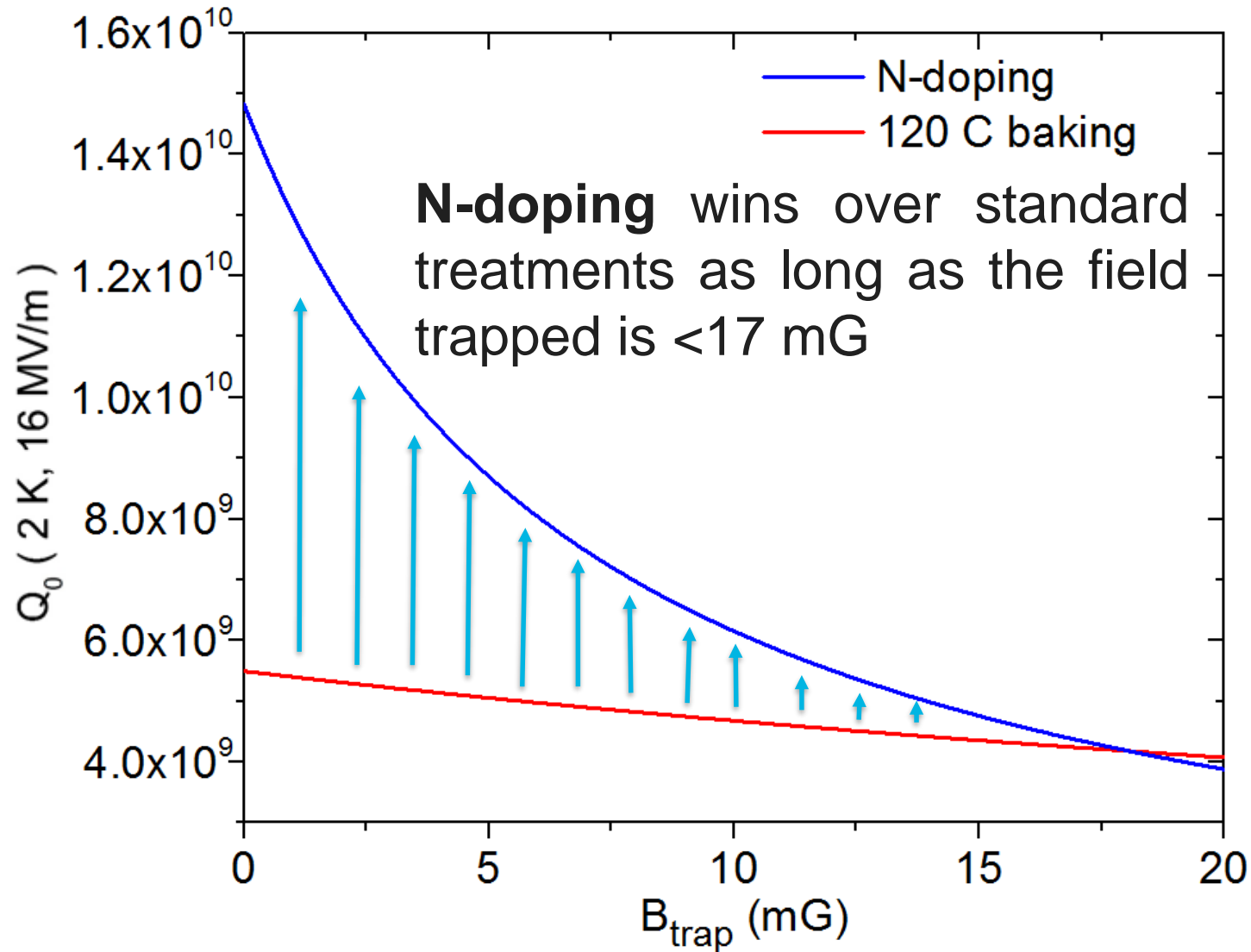


- Trapped flux sensitivity increases with frequency
- The increment strongly depends on the surface treatment, i.e. on the mean free path (see [M. Checchin TUYAA03](#))
- Higher frequencies seem to have a larger field dependence

The advantage of N-doping at 1.3 GHz



The advantage of N-doping at 3.9 GHz



Outline

- Experimental method and parameters extrapolation
- R_{BCS} field dependence
- Trapped flux sensitivity
- **N-infusion at 1.3 GHz**
- Conclusions

Motivation behind experiments

Composition and mean free path in first nanometers of cavity surface have been shown to be crucial for both Q and gradient performance

120C baking lowers the mean-free-path only at the very surface, **leading to high gradients**

120C bake, vacancies in first ~ 60 nanometers

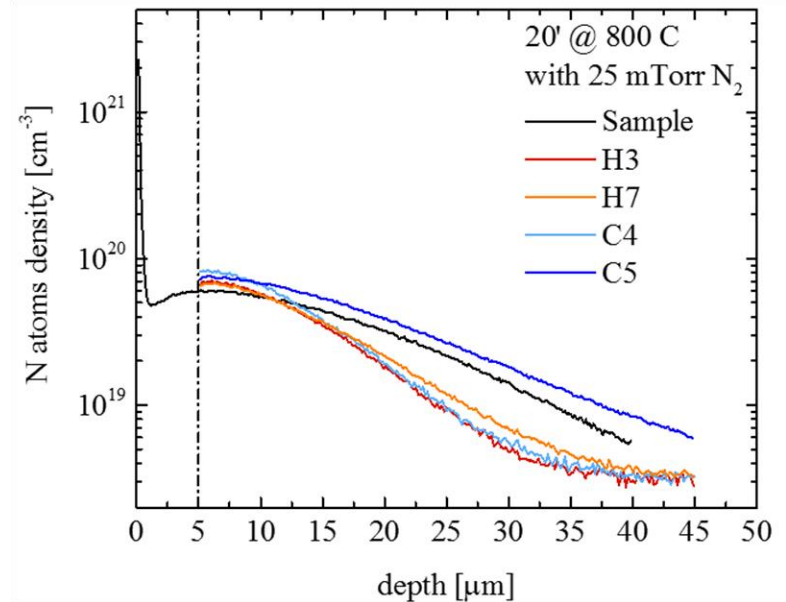
→ mfp ~ 2-16 nm

↙ mfp ~ 70 nm

A. Romanenko et al, Appl. Phys. Lett. 102, 232601 (2013)

N-Doping lowers the mean-free-path throughout several microns, **leading to high Q-factors**

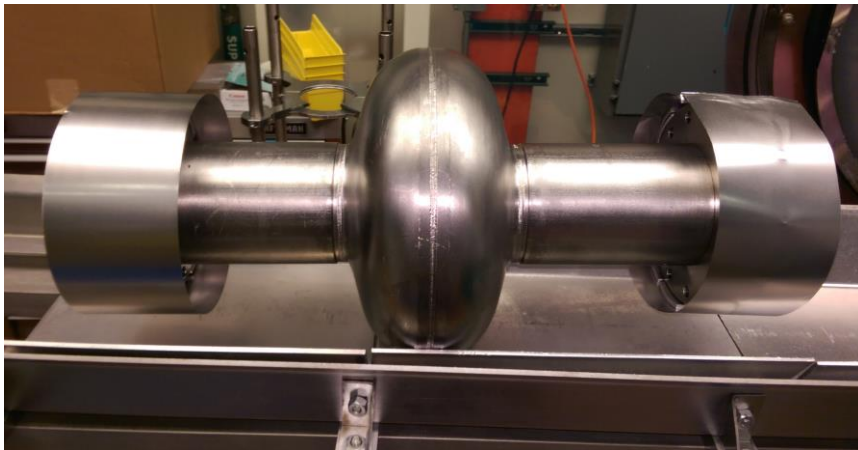
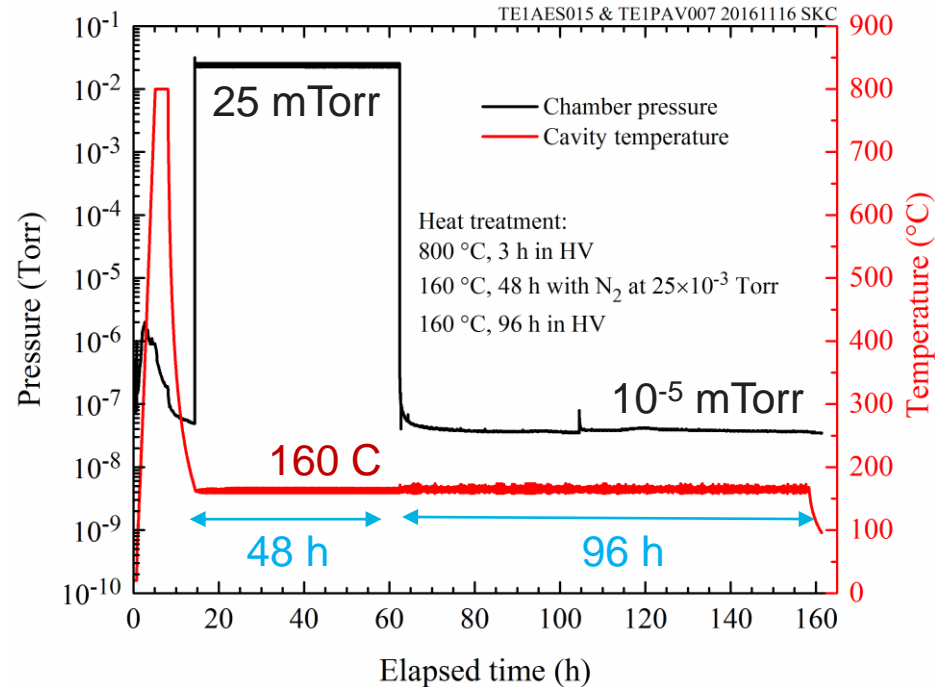
N doping: nitrogen throughout several microns



A. Grassellino et al, Proceedings of SRF 2015

Example of N-infusion processing sequence

- Bulk electro-polishing
- High T furnace (with caps to avoid furnace contamination):
 - 800C 3 hours HV
 - **120C 48 hours with N₂ (25 mTorr)**
- NO chemistry post furnace
- HPR, VT assembly



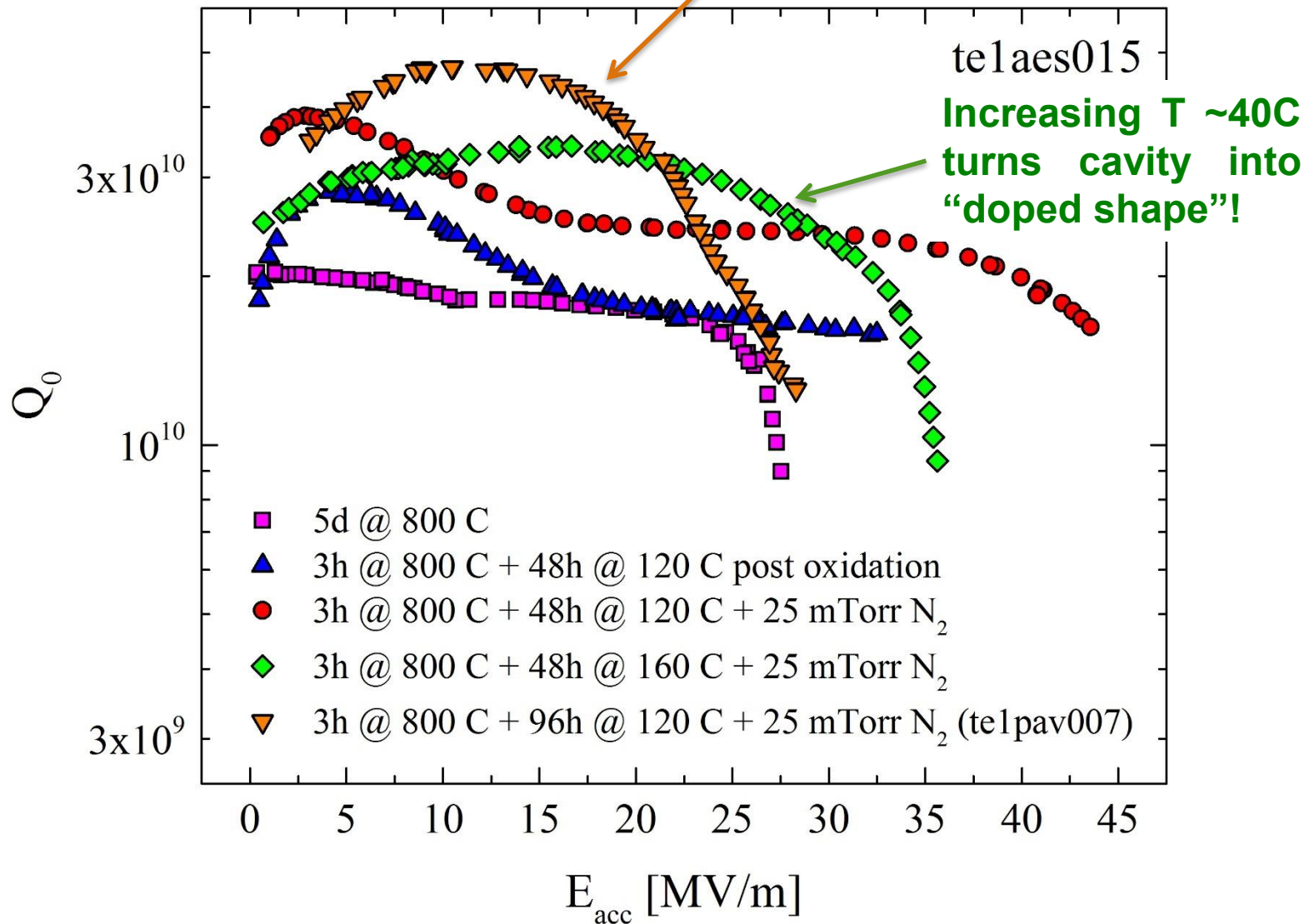
Protective caps and foils are BCP'd prior to every furnace cycle and assembled in clean room, prior to transporting cavity to furnace area

A. Grassellino *et al.*, [arXiv:1305.2182](https://arxiv.org/abs/1305.2182)

A. Grassellino *et al.*, [arXiv:1701.06077](https://arxiv.org/abs/1701.06077) in publication to SUST

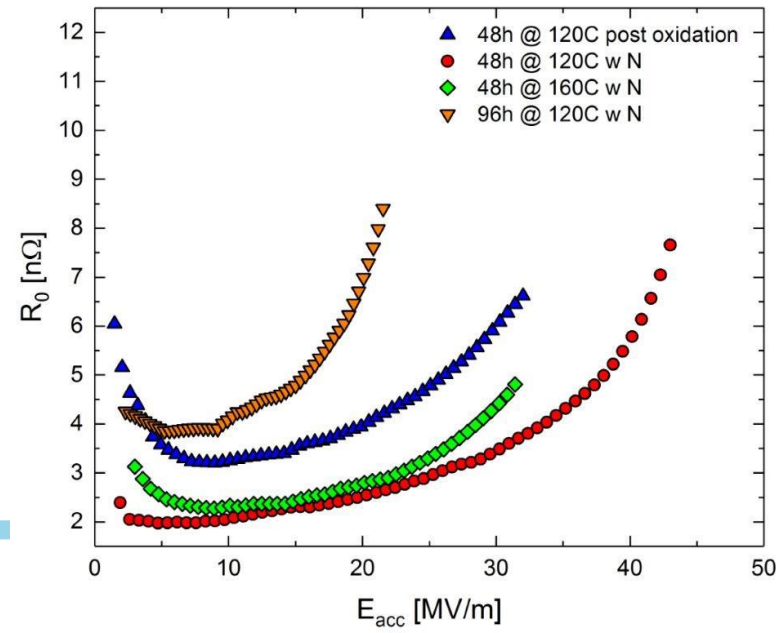
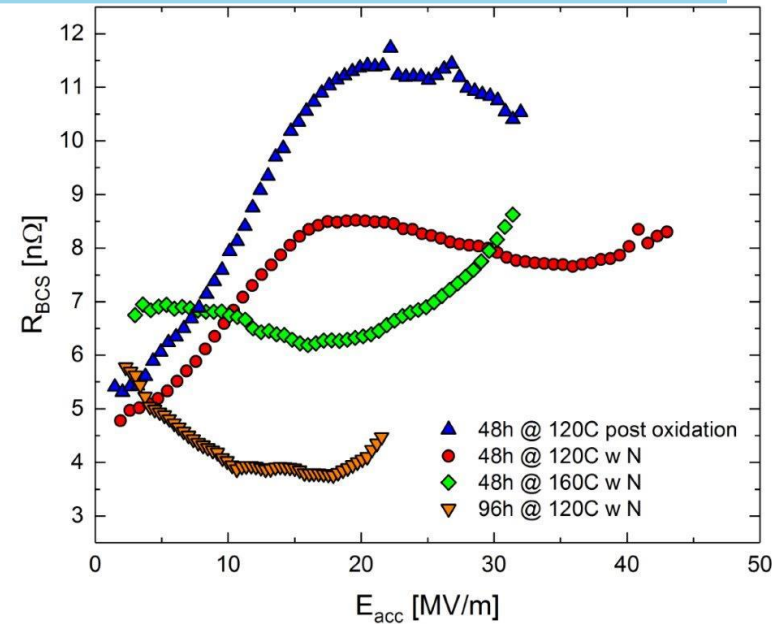
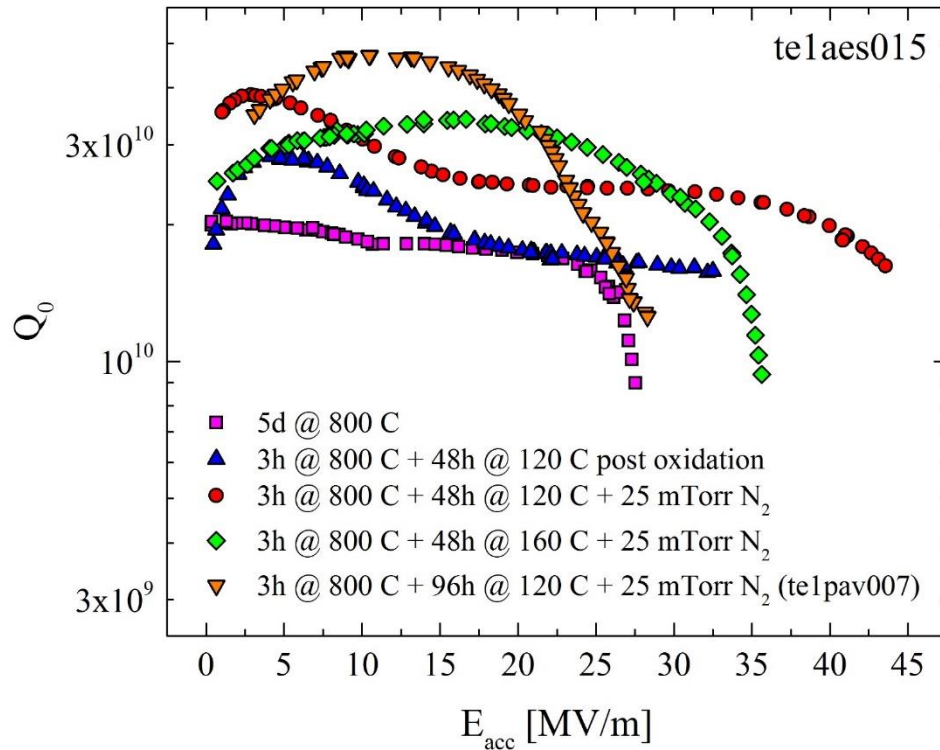
Cavity evolution

Increasing duration x 2 turns cavity into “doped shape”, even higher Q!



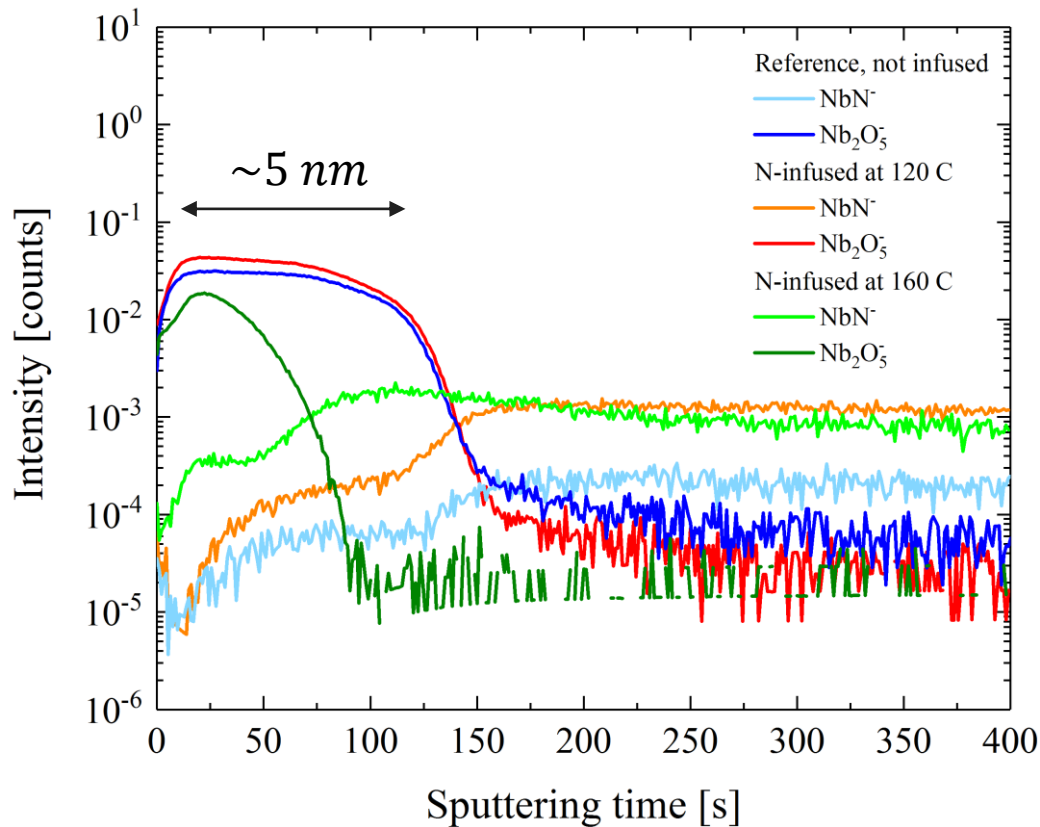
What gives the Q improvement at high fields?

Improvement stems from both lower residual and BCS resistance



A. Grassellino *et al.*, [arXiv:1701.06077](https://arxiv.org/abs/1701.06077) in publication to SUST

Role of Nitrogen in N-infusion



No nitrides formation at
the RF surface

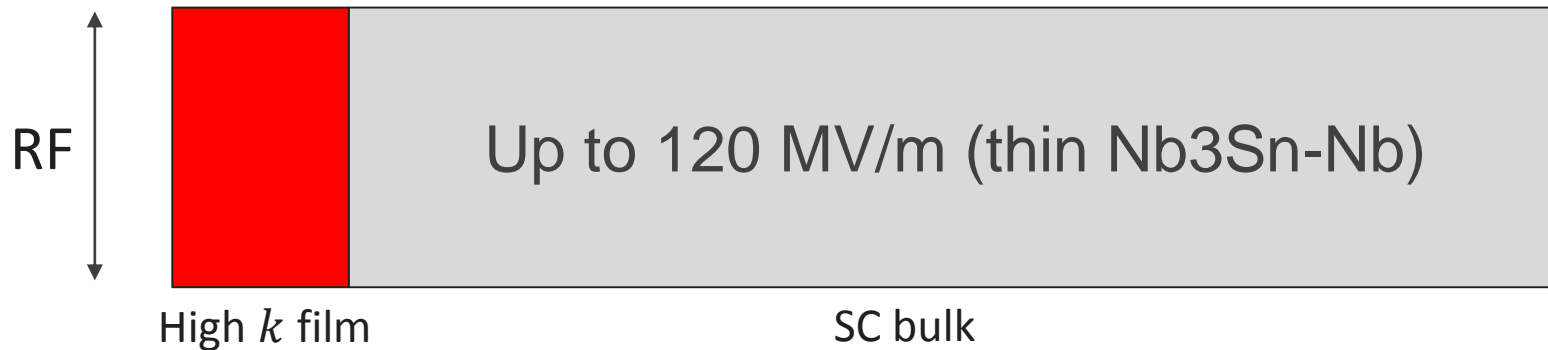
- Higher N₂ background than not infused samples
- Small ($\sim 1 - 2$ nm) N₂ enriched layer below native oxide
- SIMS data suggest that performances are related to the first nm from the RF surface

A. Grassellino *et al.*, [arXiv:1701.06077](https://arxiv.org/abs/1701.06077) (in publication to SUST)

Superconductor-Superconductor (Dirty Layer) Potential

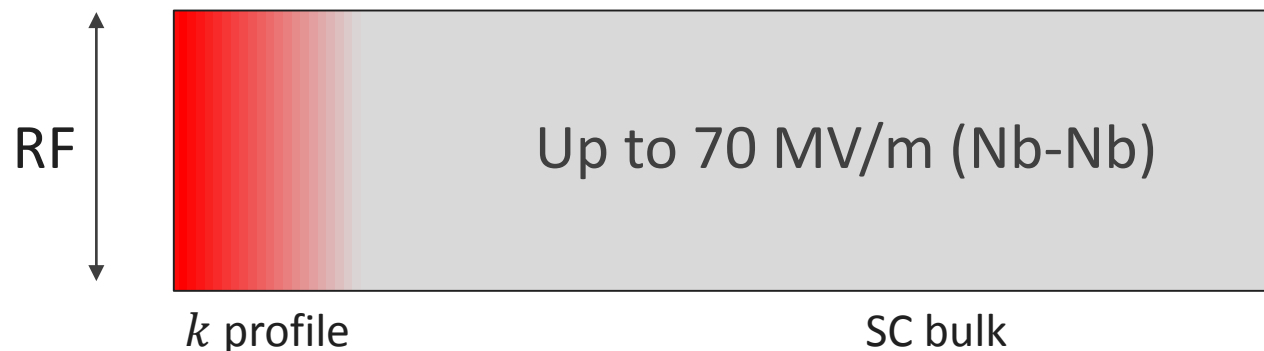
- High κ film: analytical from London eqs.

T. Kubo, Supercond. Sci. Technol. 30, 023001 (2017)



- Diffused κ profile: numerical from Ginzburg-Landau eqs.

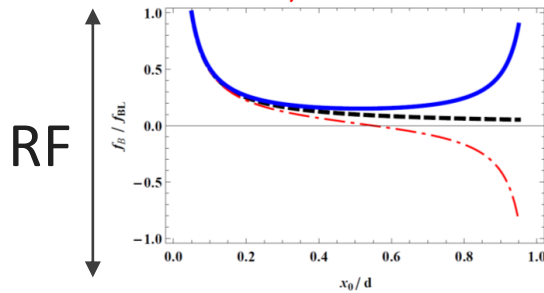
M. Checchin et al., IPAC 2016 & LINAC 2016



Can be produced
by thermal
diffusion!

Superconductor-Superconductor (Dirty Layer) Potential

- In addition to the BL barrier, we have the second barrier due to the S-S boundary. **The second barrier is also imperfect**: easily weakened by defects. **However, we have a second chance** to stop the vortex penetration.



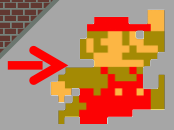
The S-S bilayer structure

- [

RF



defect



defect

defect

Bean-Livingston barrier

barrier due to the S-S boundary $\lambda_1 > \lambda_2$

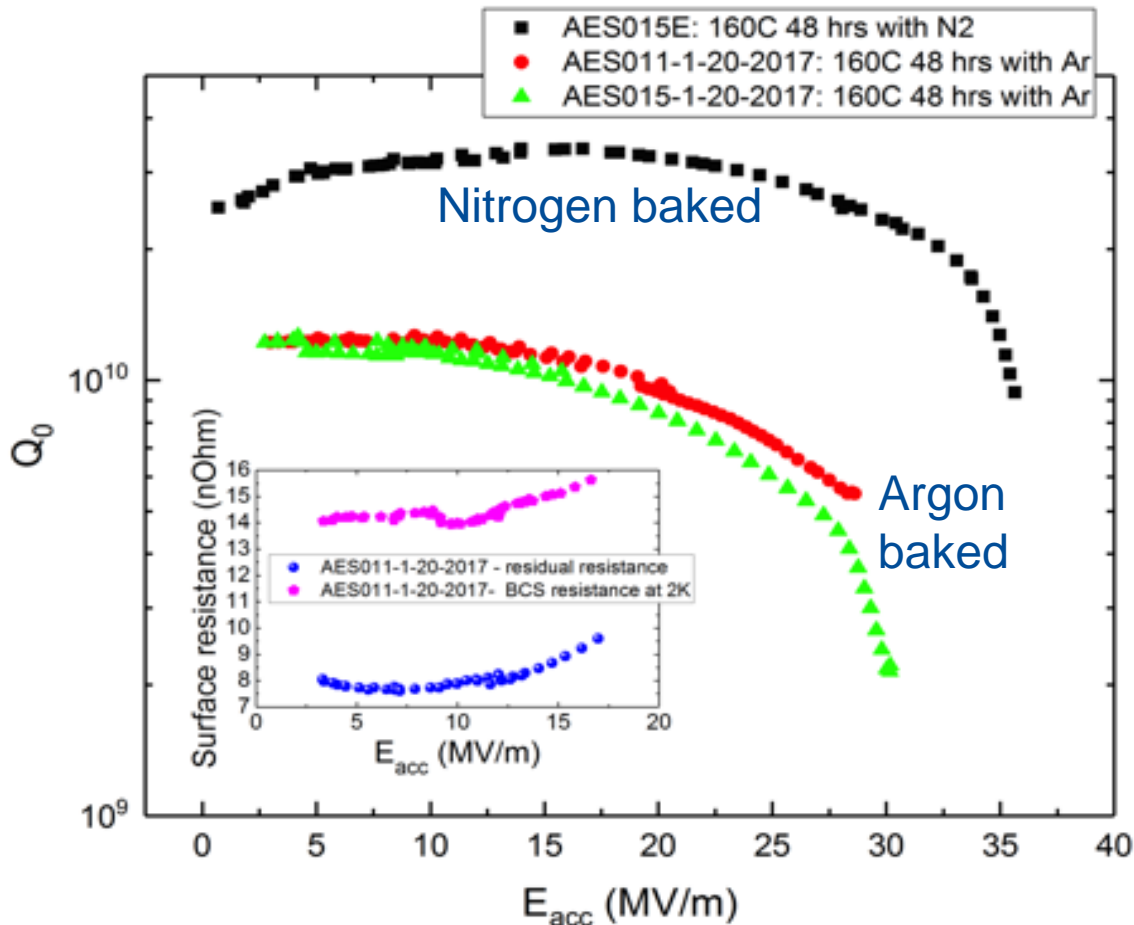
duced
nal
n!

Slide presented by T. Kubo at TTC @ Saclay

Is nitrogen really playing a role at 160C (BCS reversal)?

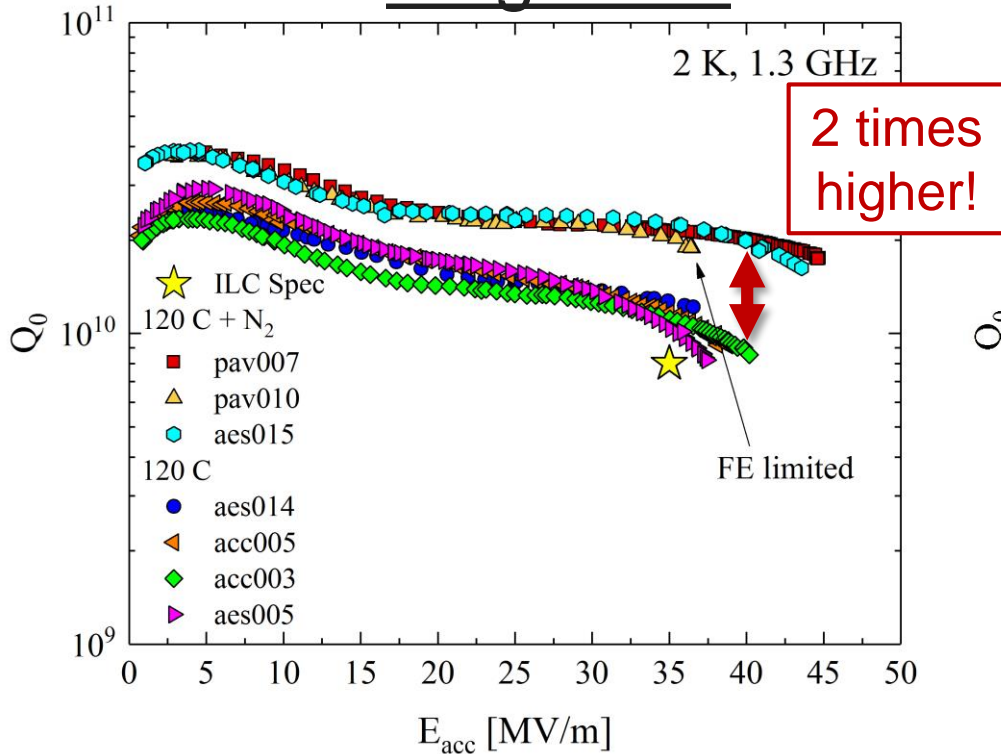
YES ✓

- Repeated same procedure with and without nitrogen in furnace at 160C (both of comparable ultra-purity 99.9999%)
- Check if other impurities may be the ones responsible for BCS reversal, rather than nitrogen

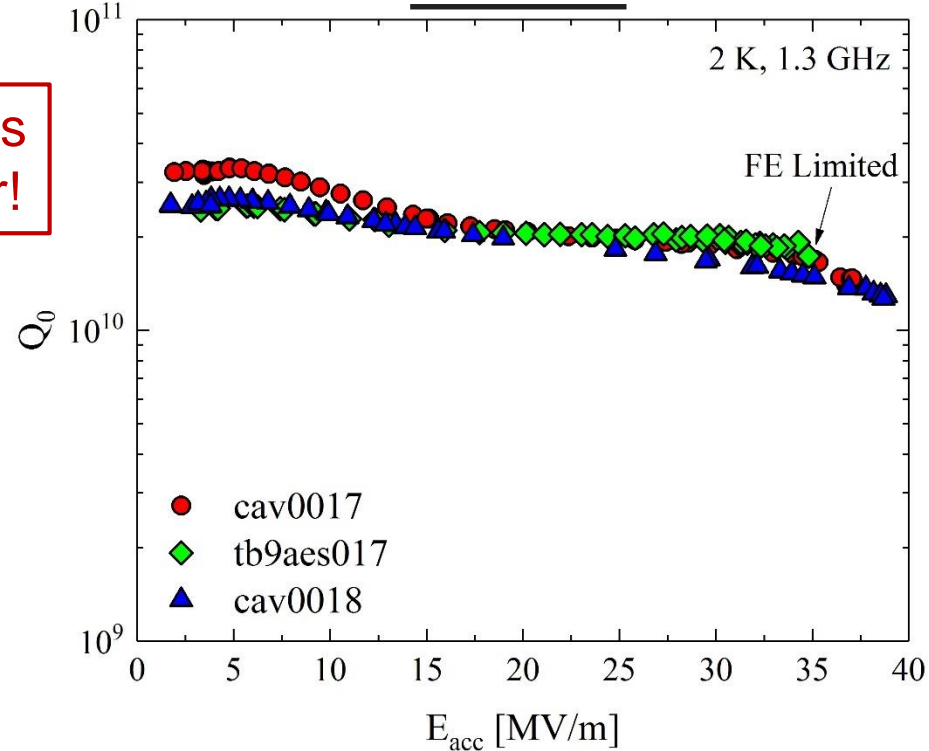


120 C N-infusion: high Q_0 at high gradients

Single-cell

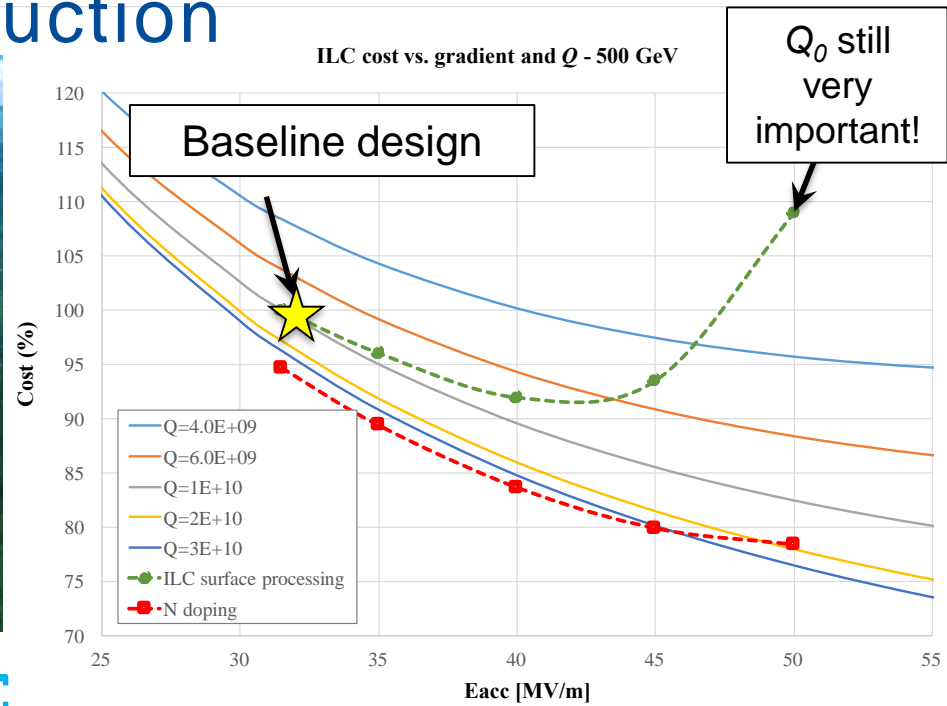


9-cells



Higher Q-factor at higher field may allow for higher duty-cycles and therefore higher luminosity!

ILC possibility of cost reduction



Outline

- Experimental method and parameters extrapolation
- R_{BCS} field dependence
- Trapped flux sensitivity
- N-infusion at 1.3 GHz
- **Conclusions**

Conclusions

- R_{BCS} field-dependence strongly depends on both the surface treatment and the cavity frequency
 - The reversal of the R_{BCS} field dependence is favorable in presence of interstitial nitrogen and/or high frequency
 - Anti Q-slope observed also in BCP'd 3.9 GHz cavities
- The trapped flux sensitivity shows a bell-shaped trend as a function of the mean free path
 - At 1.3 GHz the maximum of the curve coincides with over-doped cavities
 - N-doping still favorable at 1.3 GHz compared with standard treatment if $B_{trap} < 10$ mG
 - For same mfp, sensitivity increases with the frequency
- N-infusion capable to modify cavity surface at the nm scale, resulting in high Q-factor at high gradient
 - Very promising for ILC cost reduction

Thank you for your
attention!

